



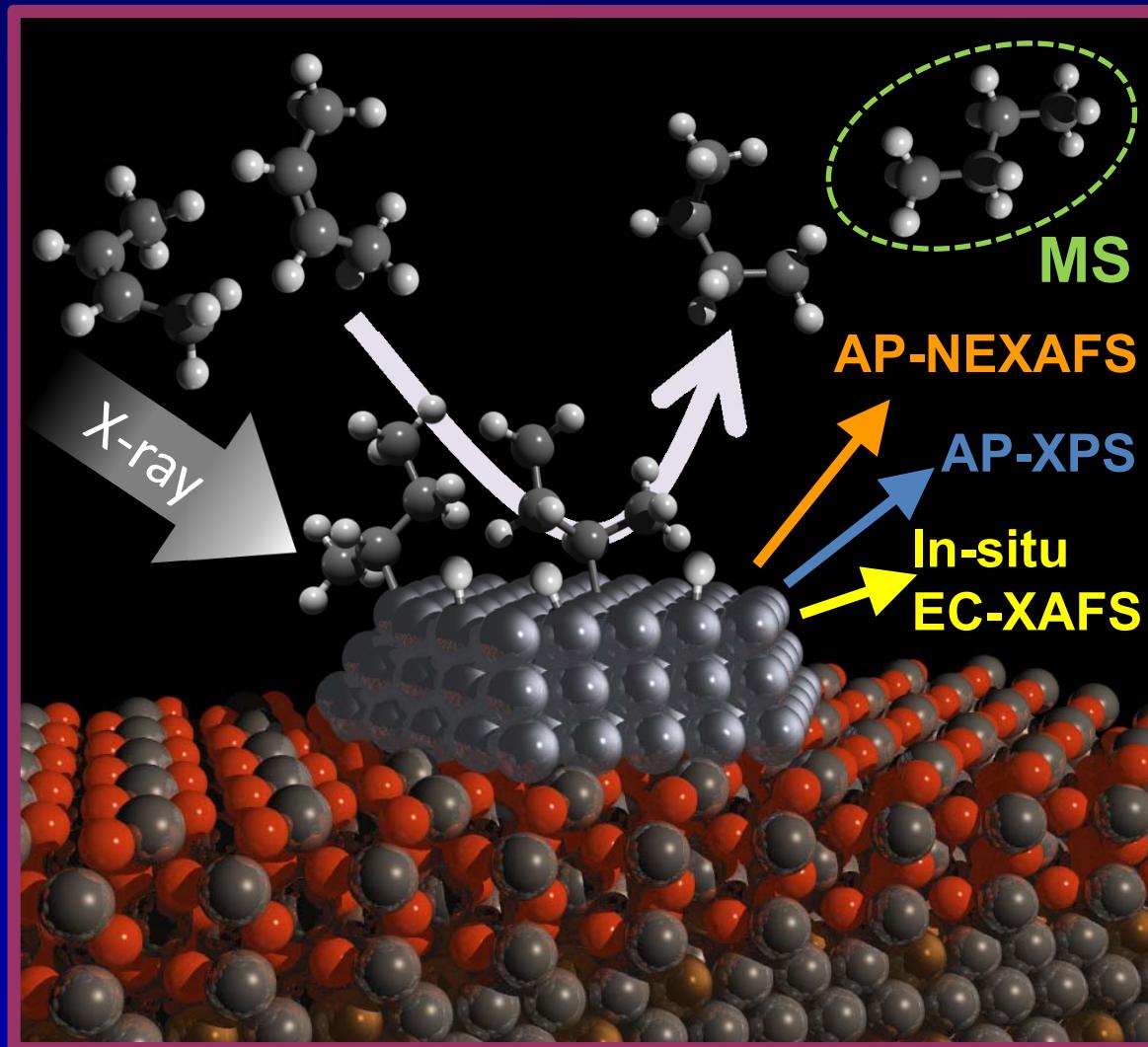
SPring-8 グリーンサステイナブル
ケミストリー研究会
平成27年12月8日(品川)

機能する触媒を観る —軟X線オペランド分光によるアプローチ—

近藤 寛

慶應義塾大学

触媒表面で進む化学反応をX線で捉える(X線オペランド観測)





アウトライン

背景

軟X線オペランド観測手法

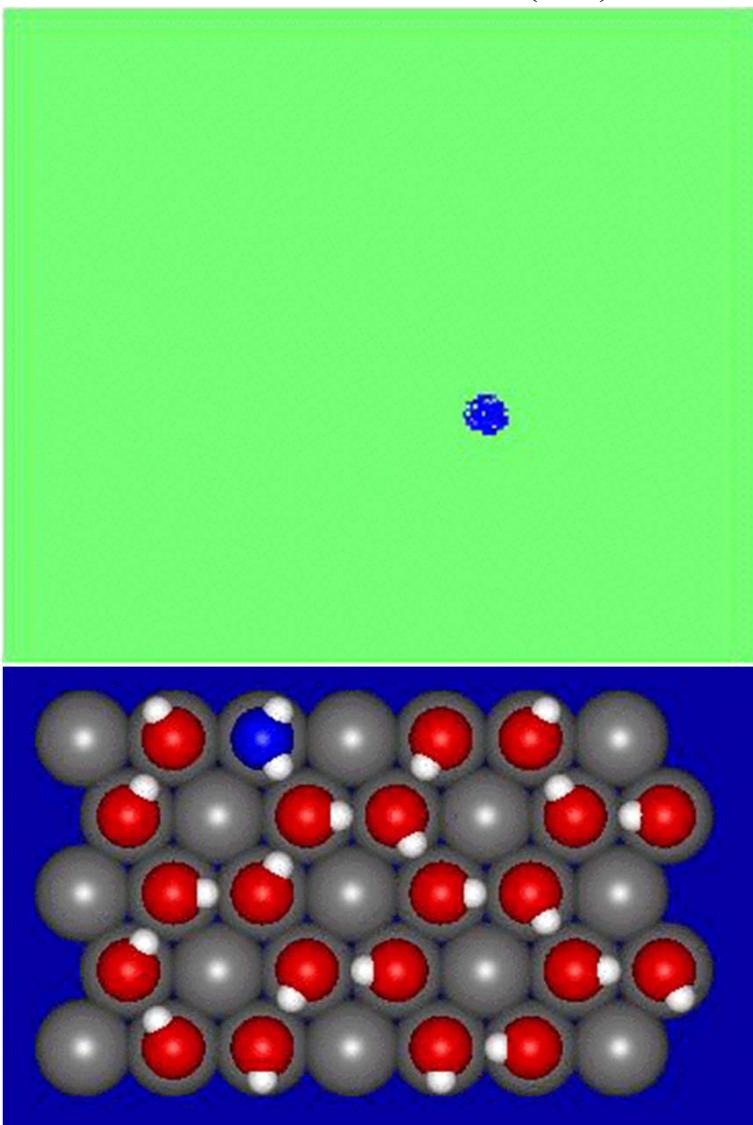
触媒が活性になったときに見えるもの

NAP-XPSによる排気ガス浄化触媒
電気化学XAFSによる水分解触媒



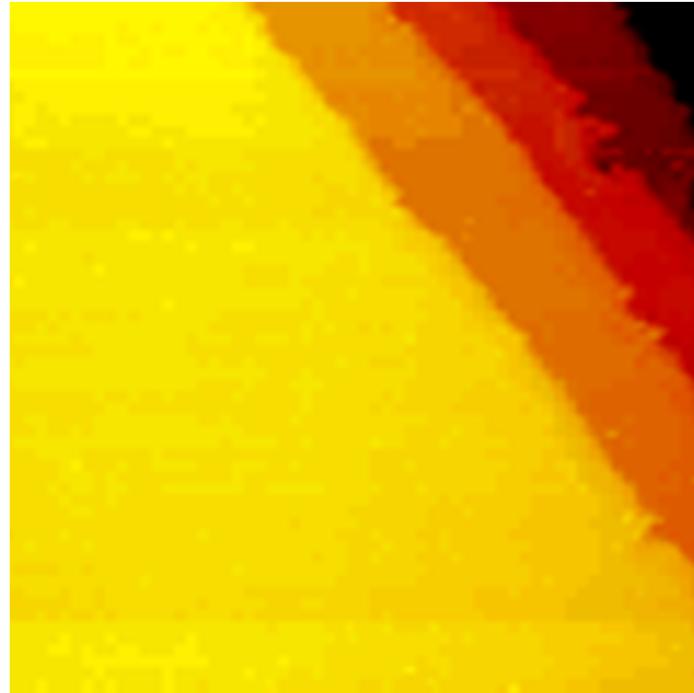
Catalytic Surface Reactions

Water formation on Pt(111)



Nagasaka et al. (Univ. Tokyo)

Carbonyl formation on NiAu

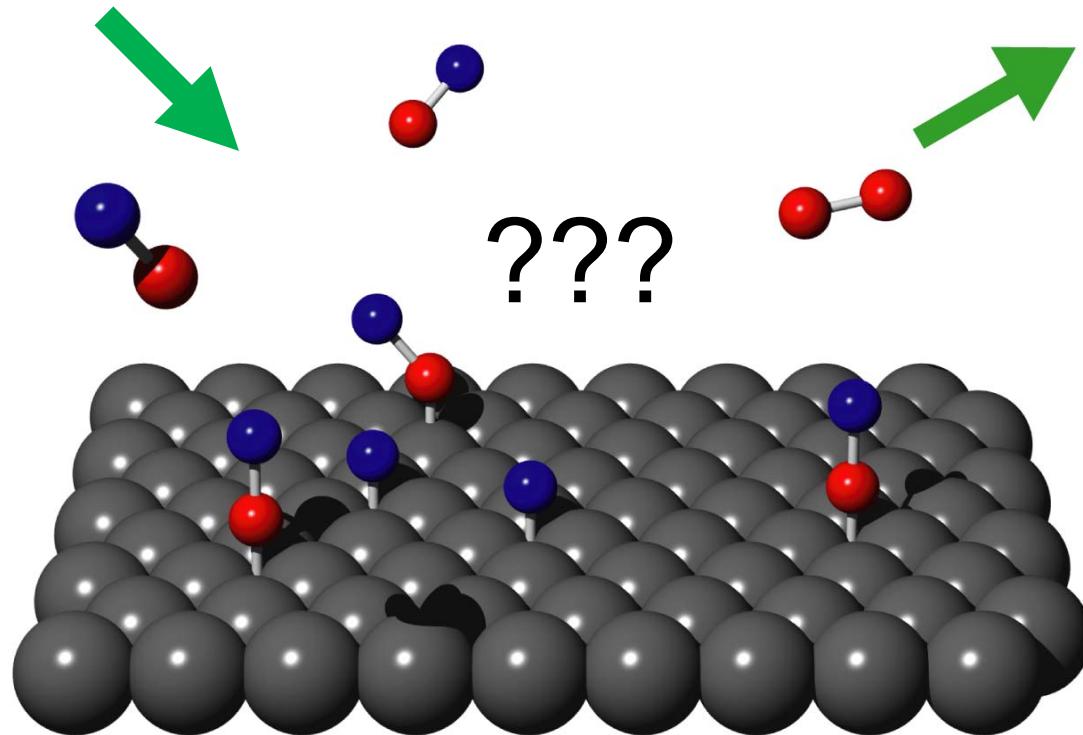


Besenbacher et al. (Aarhus Univ.)

attractive but not simple
phenomena.....



Catalytic Surface Reaction



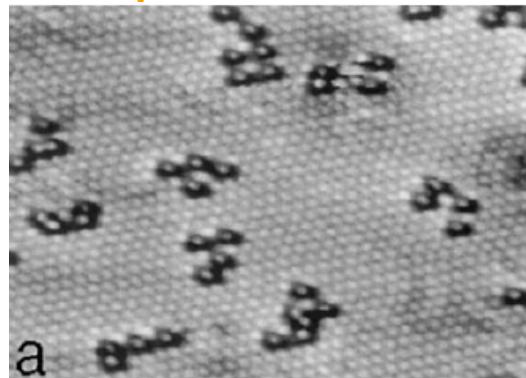
Elementary Step

- Adsorption
- Diffusion
- Reaction
- Desorption
- :



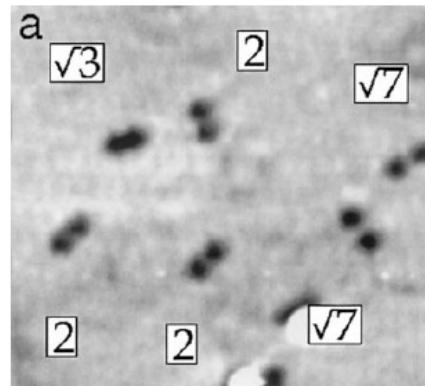
Surface science analysis of each elementary step

Adsorption

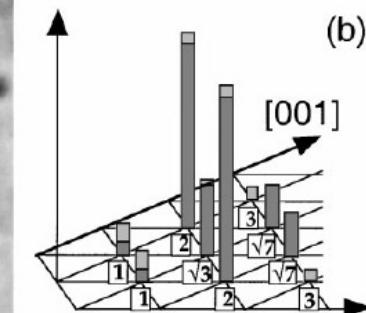


Precursor-mediated adsorption
for O₂/Pt(111)

T. Zambelli et al. *Nature* **390**, 495 (1997).

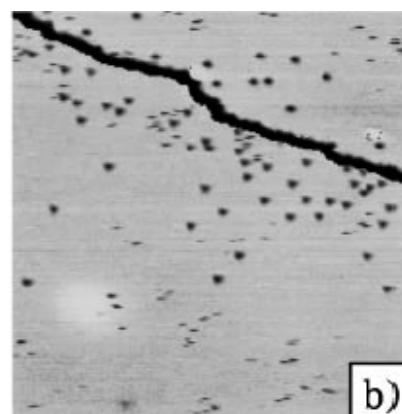
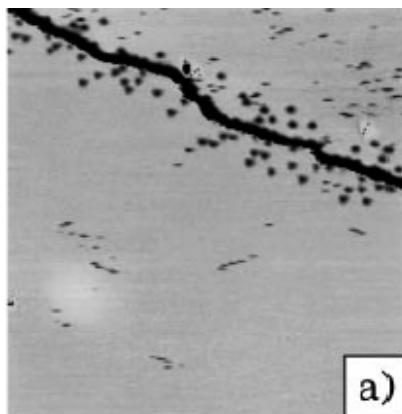


Hot-atom formation on adsorption
for O₂/Pt(111)



J. Wintterlin et al. *Phys. Rev. Lett.* **77**, 123 (1996).

Surface diffusion



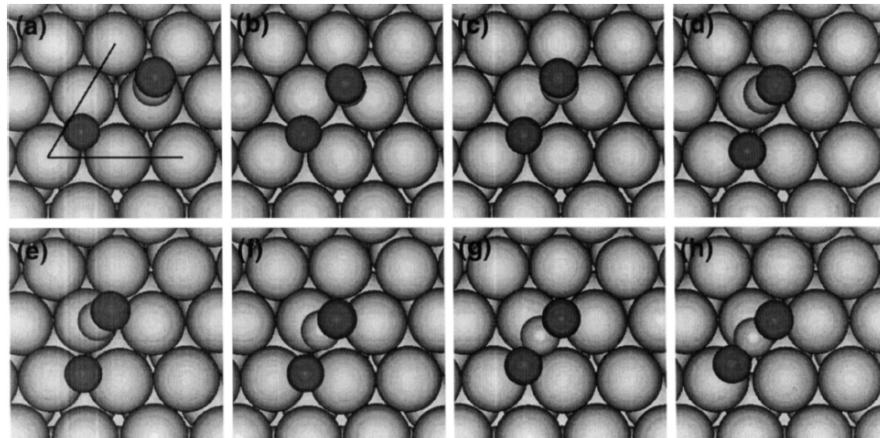
Surface diffusion of atomic N
from a step on Ru(0001)

T. Zambelli et al.
Phys. Rev. Lett. **76**, 795 (1996).



Surface science analysis of each elementary step

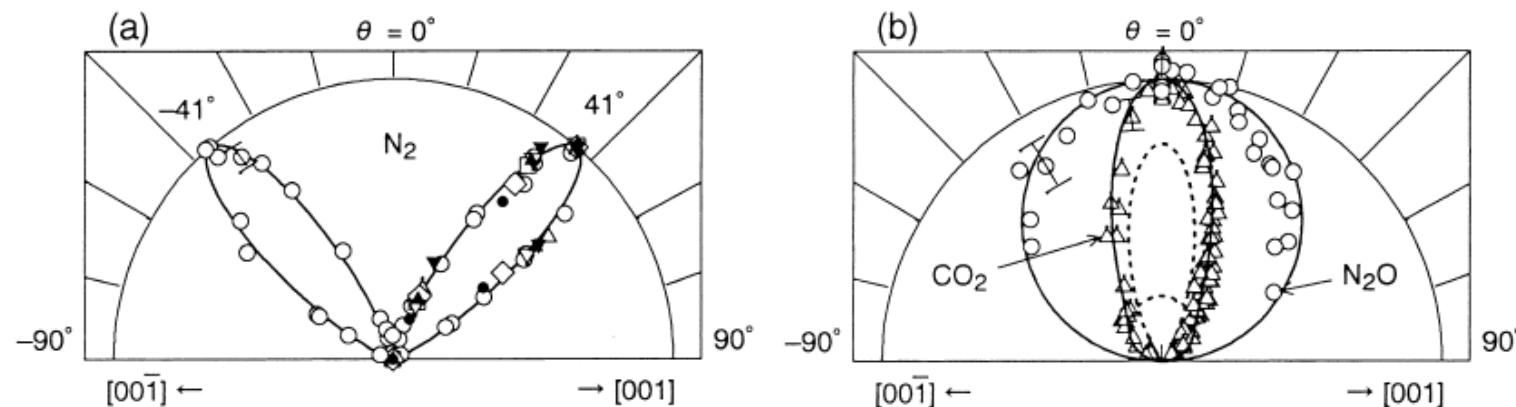
Reaction



Reaction pathway of CO oxidation on Pt(111)
deduced from DFT calculations

A. Alavi et al.
Phys. Rev. Lett. **80**, 3650 (1998).

Desorption

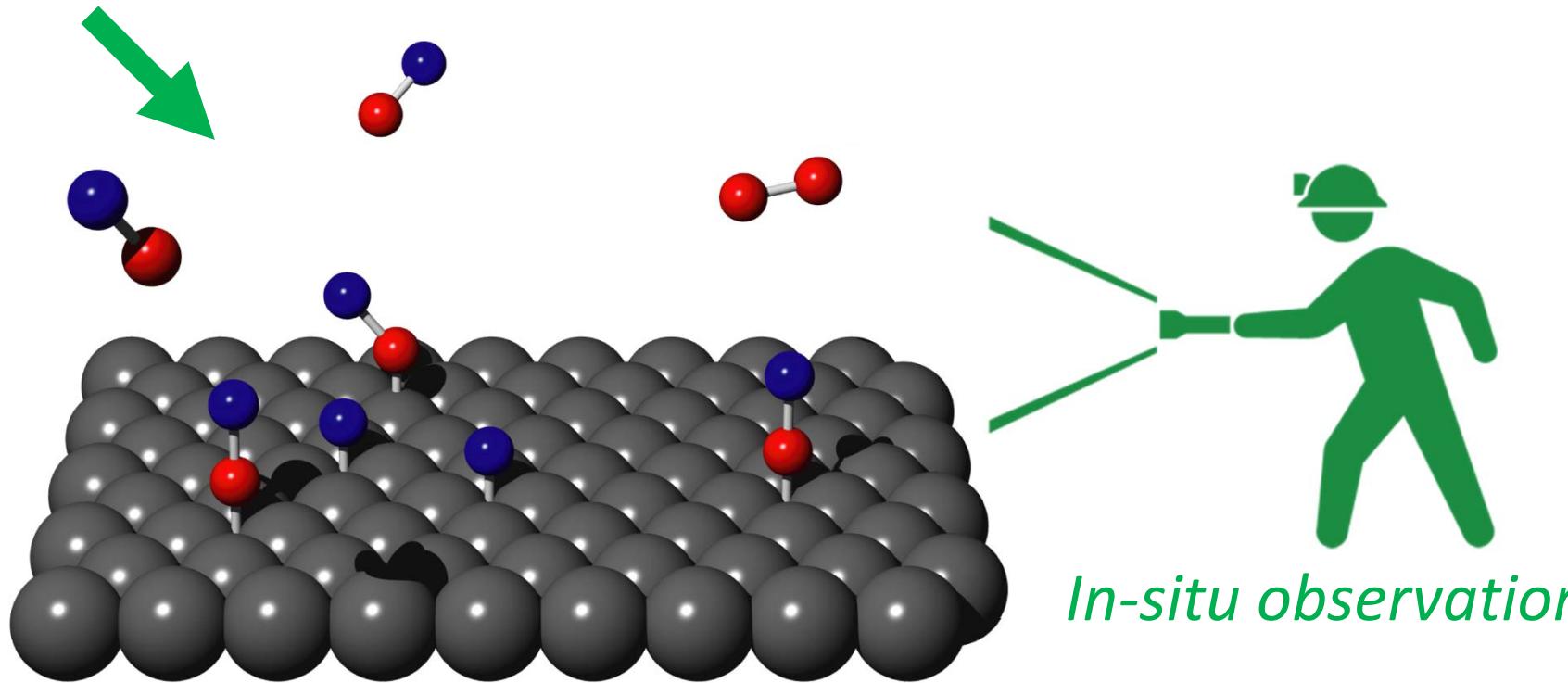


Angular distribution of desorption species via CO+NO reaction on Pd(110)

T. Matsushima, *Surf. Sci. Rep.* **22**, 127 (1995).



Catalytic Surface Reaction



- Elementary Step
- Adsorption
 - Diffusion
 - Reaction
 - Desorption
 - :
- mutually correlating



In-situ observation with microscopy

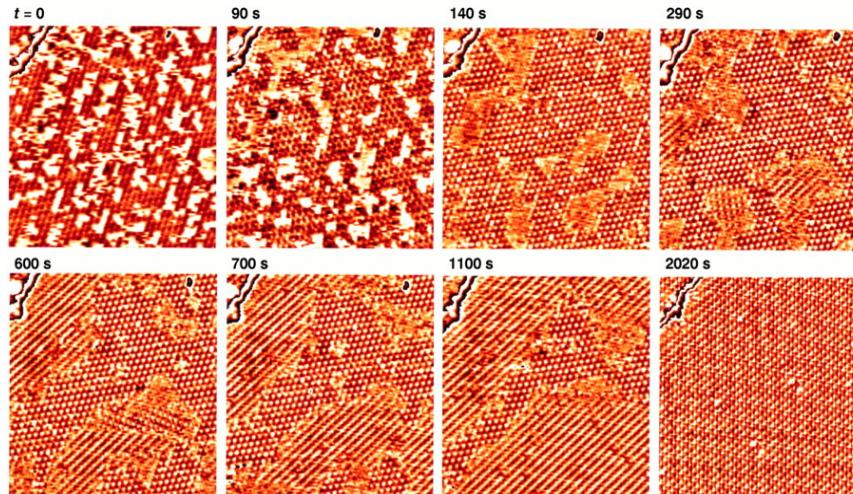
PEEM



Spatiotemporal evolution of chemical waves of CO oxidation on Pt(110)

S. Nettesheim, A. von Oertzen, H. H. Rotermund and G. Ertl, *J. Chem. Phys.* **98**, 9977 (1993).

STM



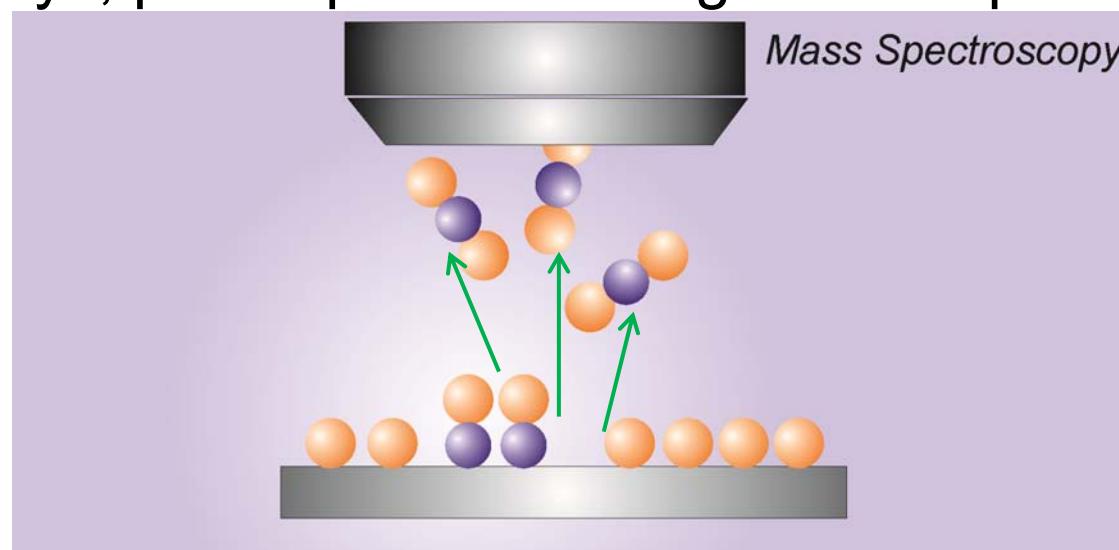
Site specific reaction of CO oxidation on Pt(111)

J. Wintterlin, S. Völkening, T. V. W. Janssens, T. Zmbelli and G. Ertl, *Science* **278**, 1931 (1997).

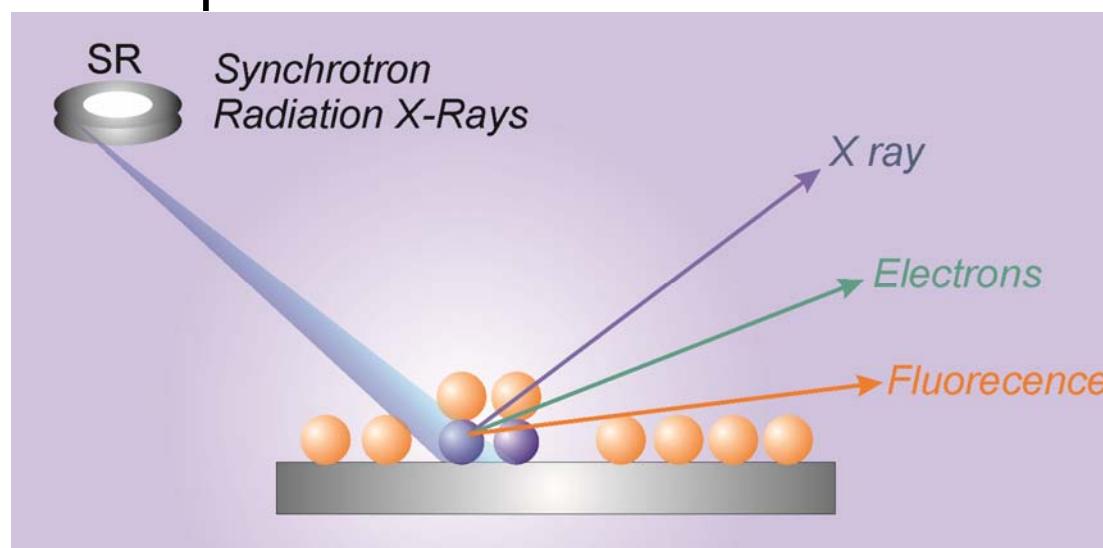


In-situ observation with spectroscopy

- From the early days, partial pressures of gaseous species were monitored

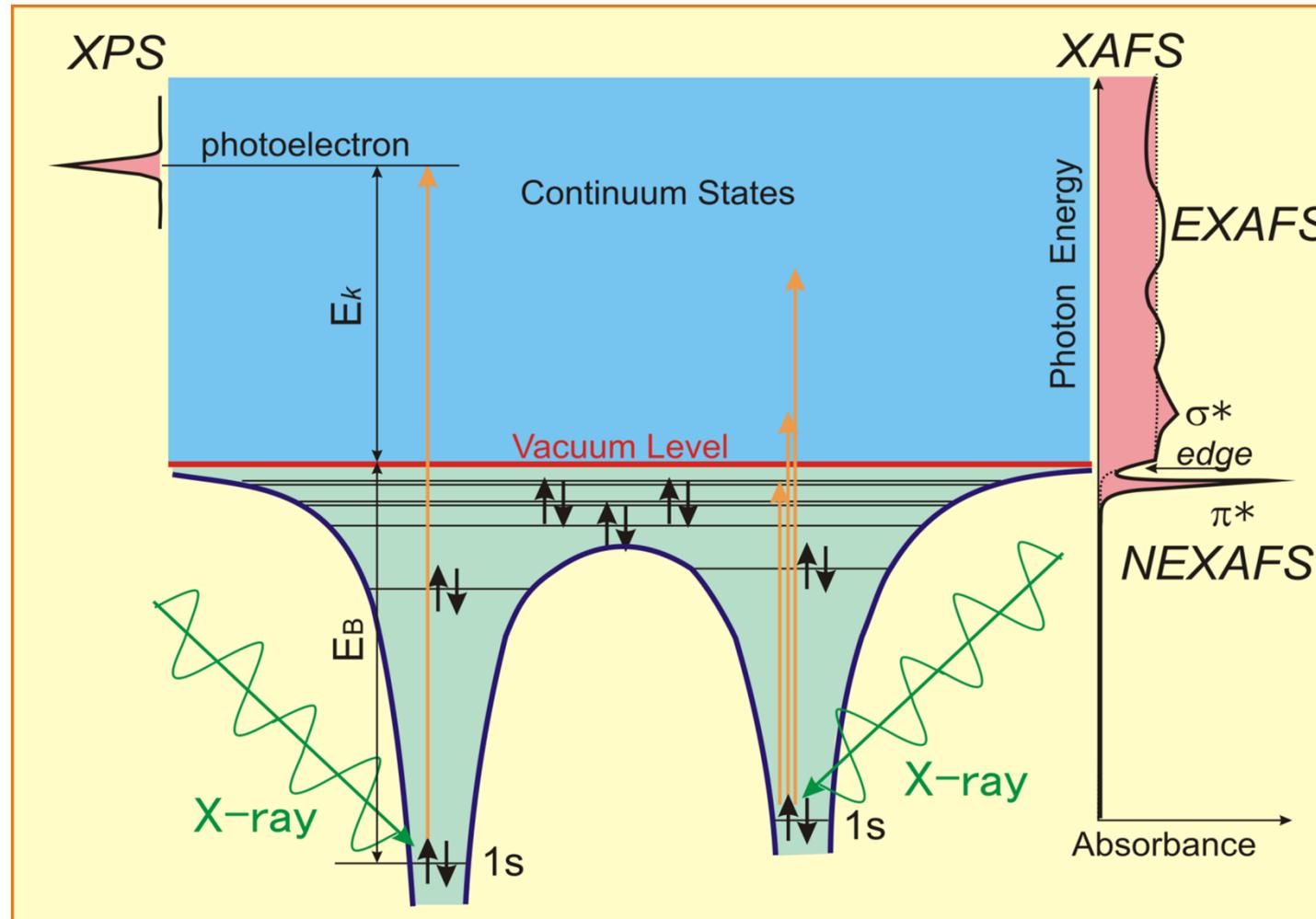


- Observation of surface species with SR-based core-level spectroscopy





SR-based X-ray spectroscopy (XPS & XAFS)

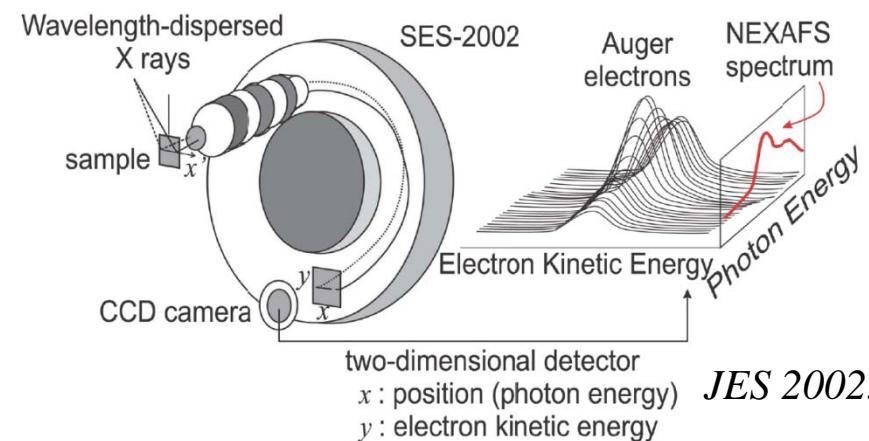
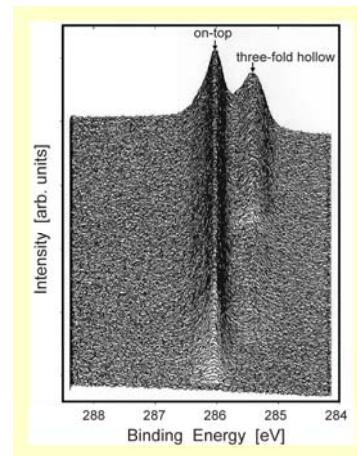


- Chemical states for substrate and adsorbate
- Geometric and electronic structures



SR-based electron-detecting techniques for in-situ monitoring under UHV conditions

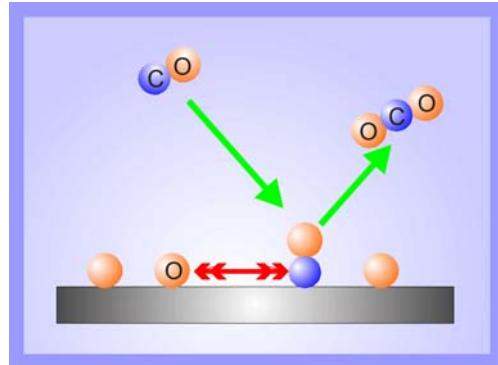
- *Fast-XPS*
- *Fast-NEXAFS*
- *Micro-XPS*



JES 2002.

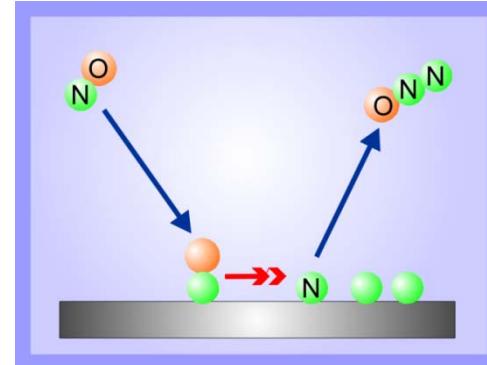
Previous our studies...

CO oxidation



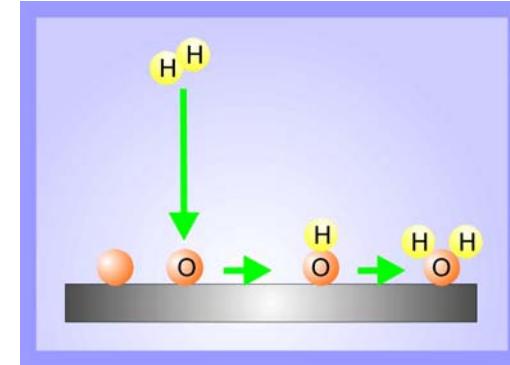
- J. Chem. Phys.* **122**, 134709 (2005).
J. Chem. Phys. **124**, 224712 (2006).
J. Chem. Phys. **126**, 044704 (2007).
Appl. Phys. Lett. **99**, 074104 (2011)

NO reduction



- J. Phys. Chem. B* **110**, 25578 (2006).
J. Chem. Phys. **127**, 024701 (2007).
J. Phys. Chem. C **113**, 13257 (2009).

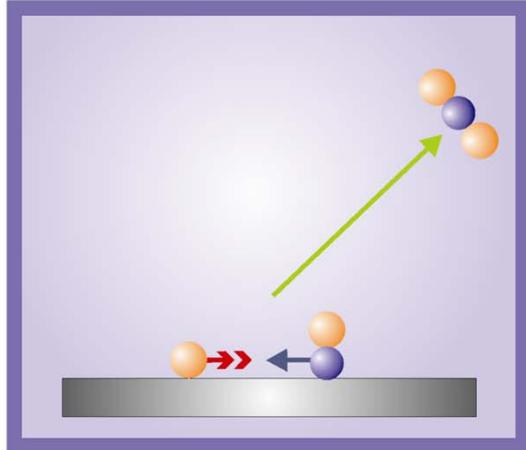
H₂O formation



- J. Chem. Phys.* **119**, 9233 (2003).
J. Chem. Phys. **122**, 204704 (2005).
Phys. Rev. Lett. **100**, 106101 (2008)

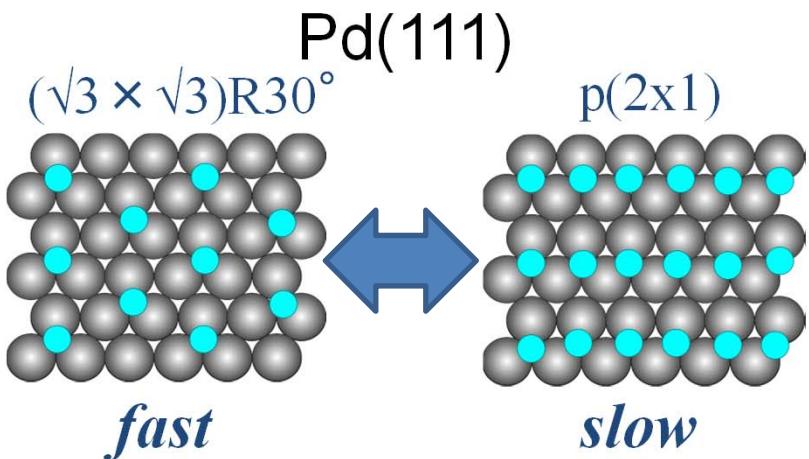


In-situ observations under UHV conditions

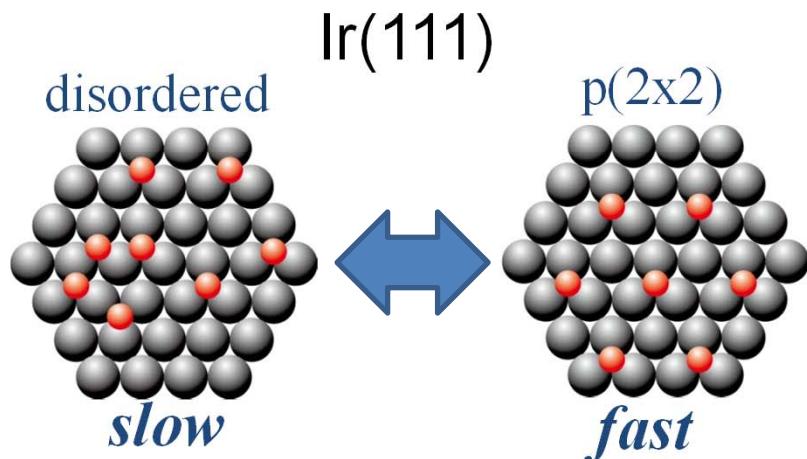


Langmuir-Hinshelwood mechanism
both for Pd and Ir under UHV

Phase-dependent reactivity both for Pd and Ir under UHV



J. Chem. Phys. **124**, 224712 (2006).

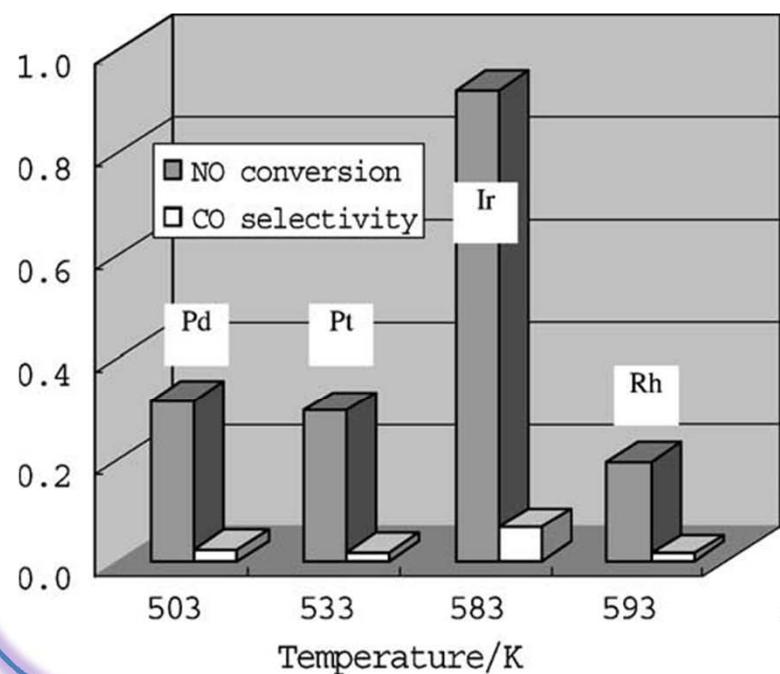


Appl. Phys. Lett. **99**, 074104 (2011).



Practical catalytic reaction under ambient-pressure conditions

Activity of PGM catalysts for the NO reduction by CO under an ambient-pressure (AP) condition



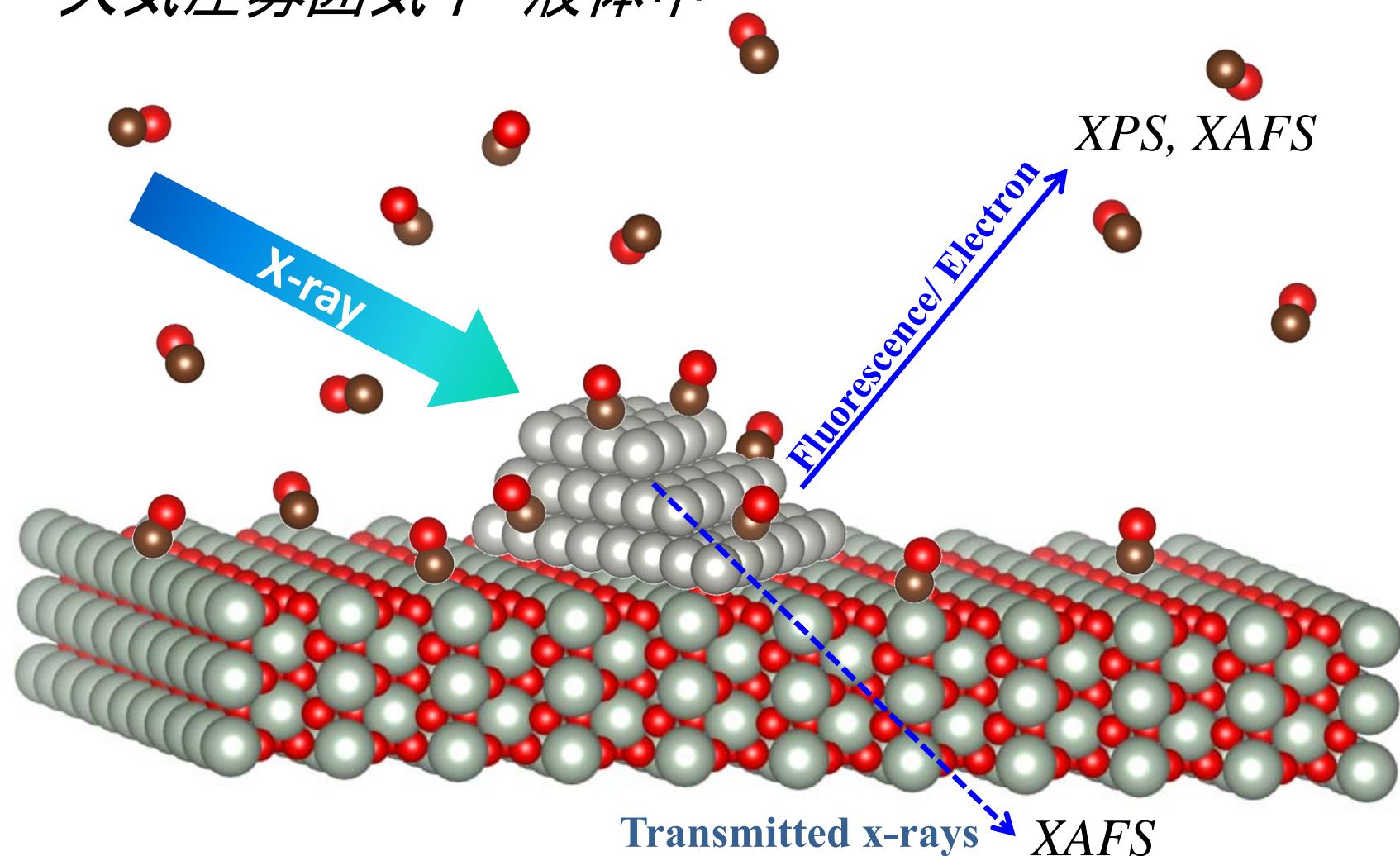
Pd and Ir catalysts:
Large difference in activity
under AP condition

A. Wang et al. *Appl. Catal., B*, **40**, 319 (2003)



実作動条件下の触媒を直接見たい

大気圧雰囲気下・液体中





目次

背景

軟X線オペランド観測手法

触媒が活性になったときに見えるもの

NAP-XPSによる排気ガス浄化触媒

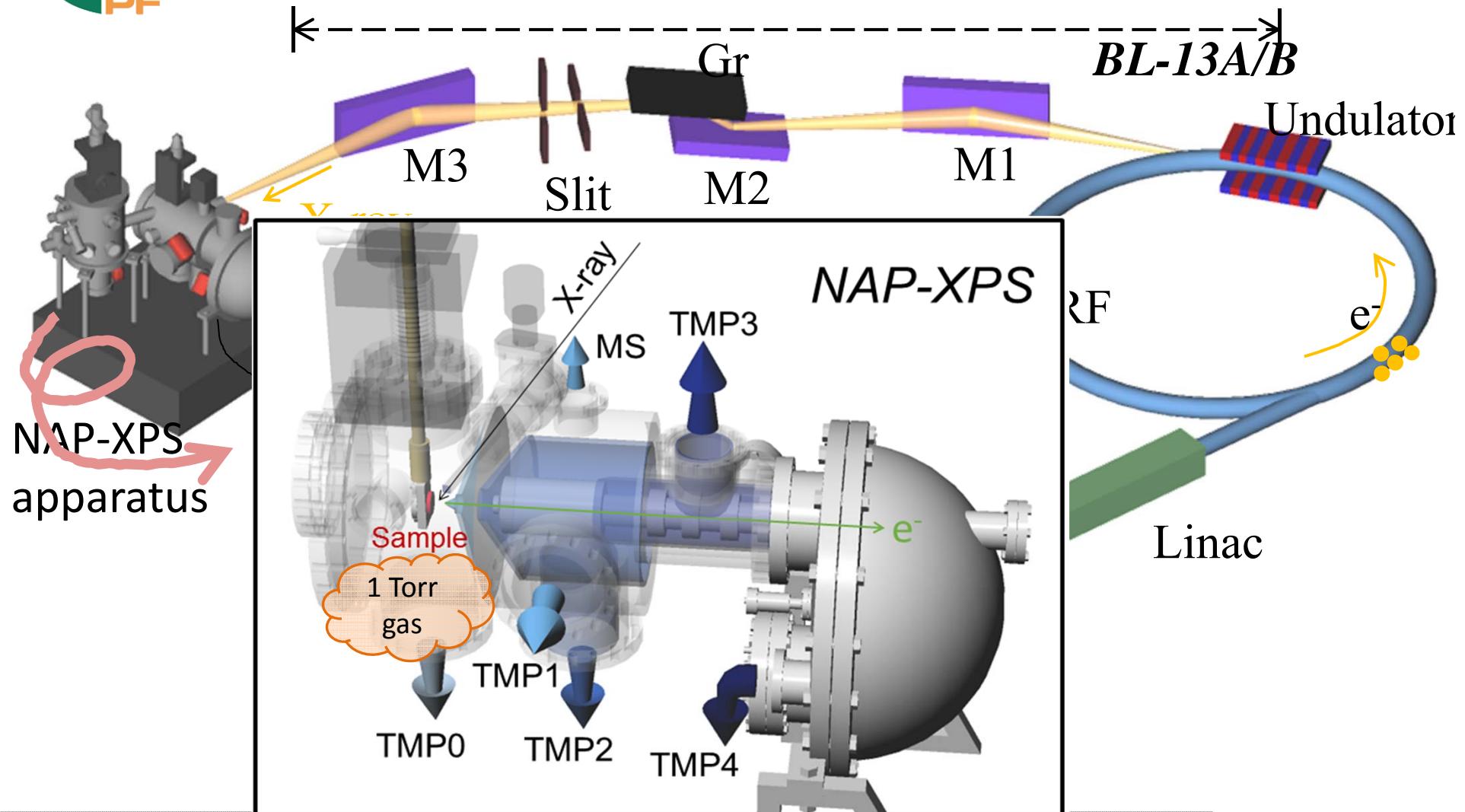
電気化学XAFSによる水分解触媒



NAP-XPS at the Photon Factory

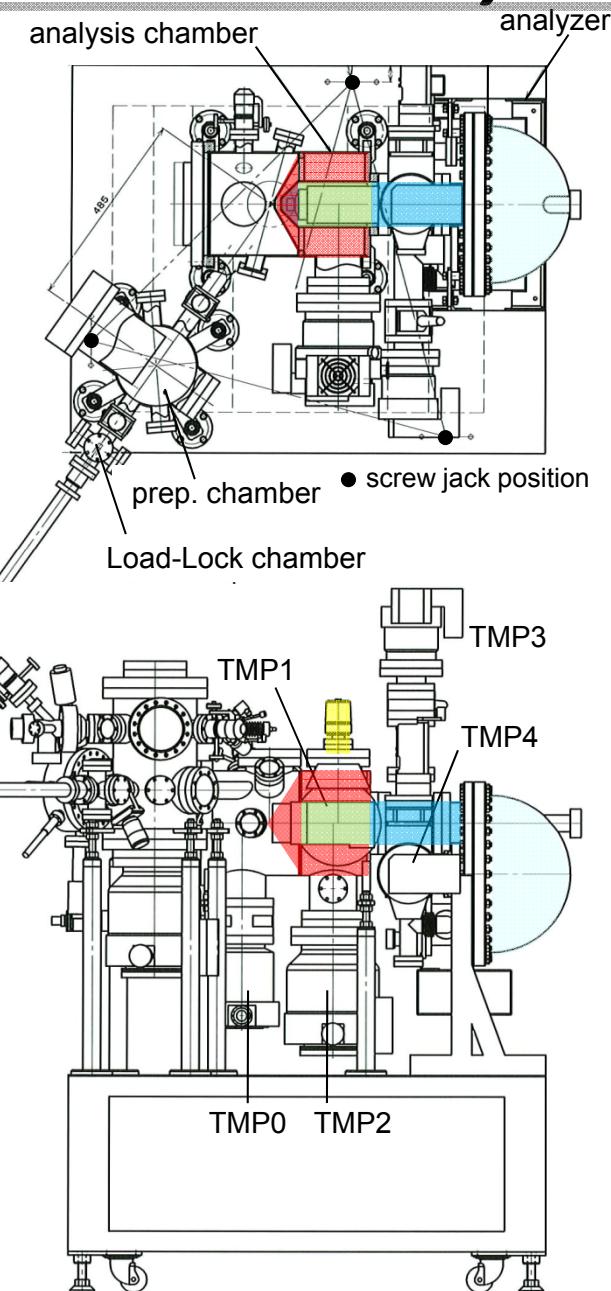


High Energy Accelerator Research organization Photon Factory (KEK-PF)



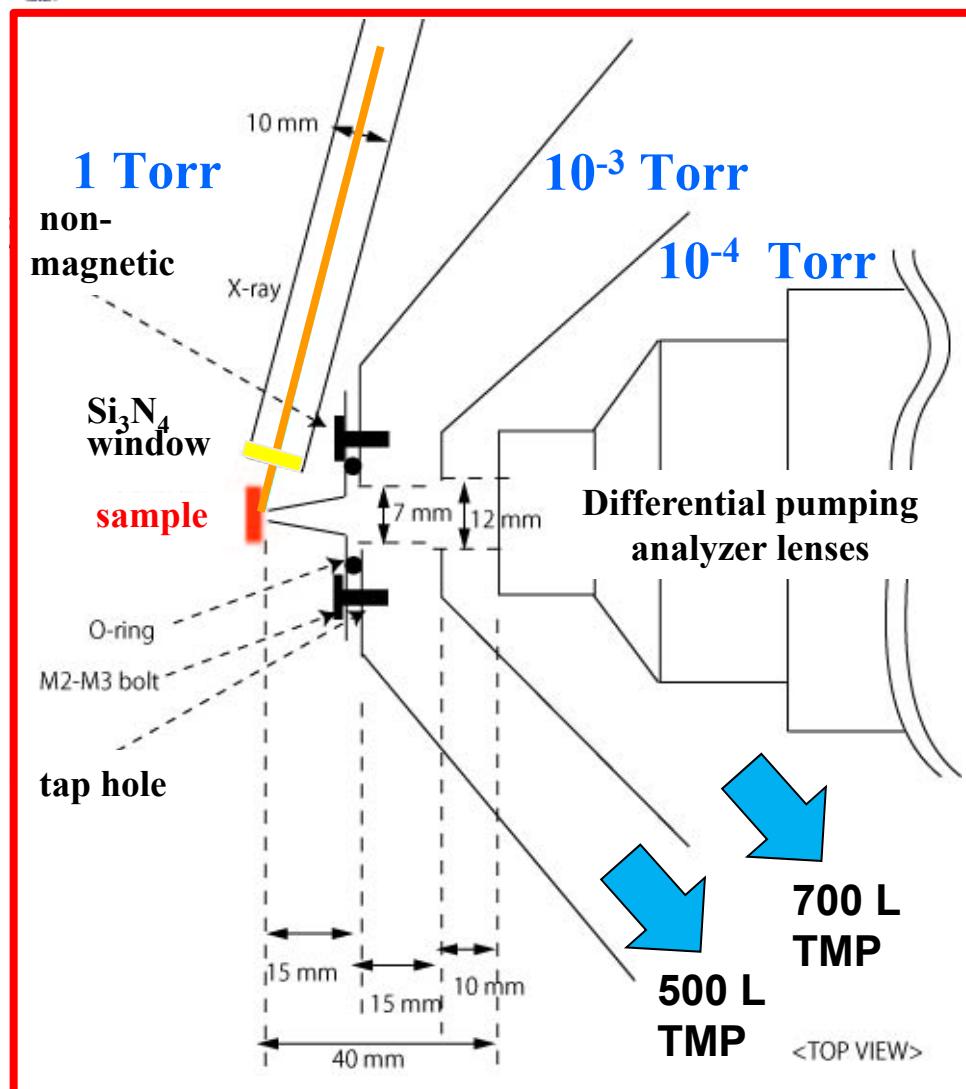


NAP-XPS at the Photon Factory

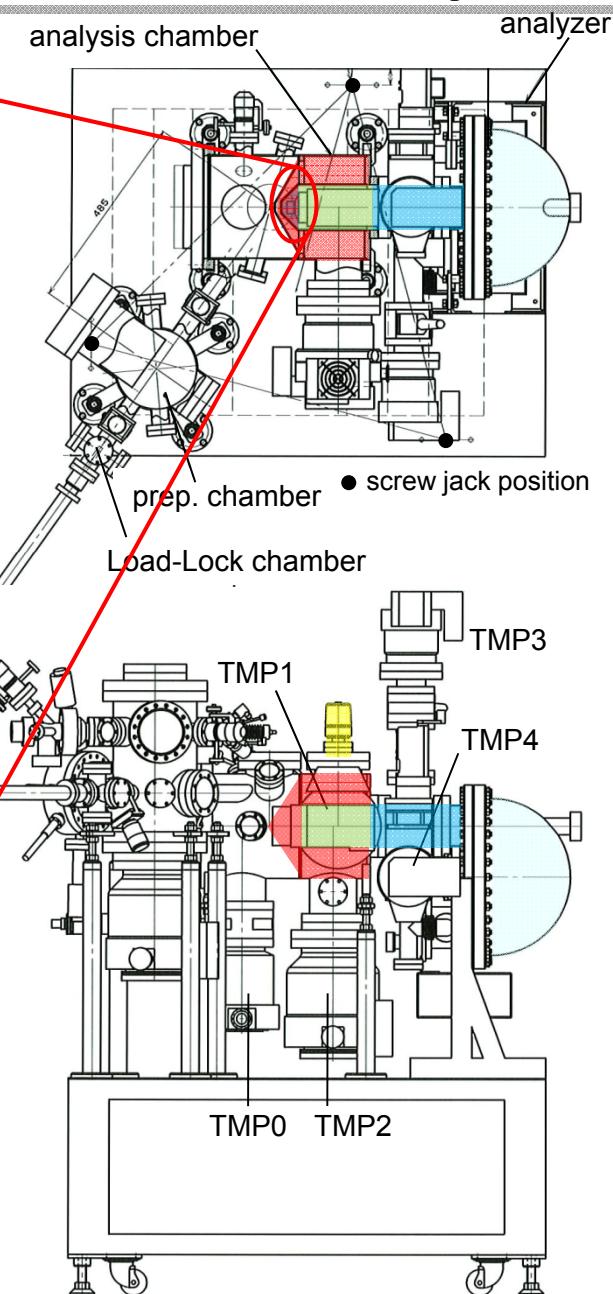




NAP-XPS at the Photon Factory



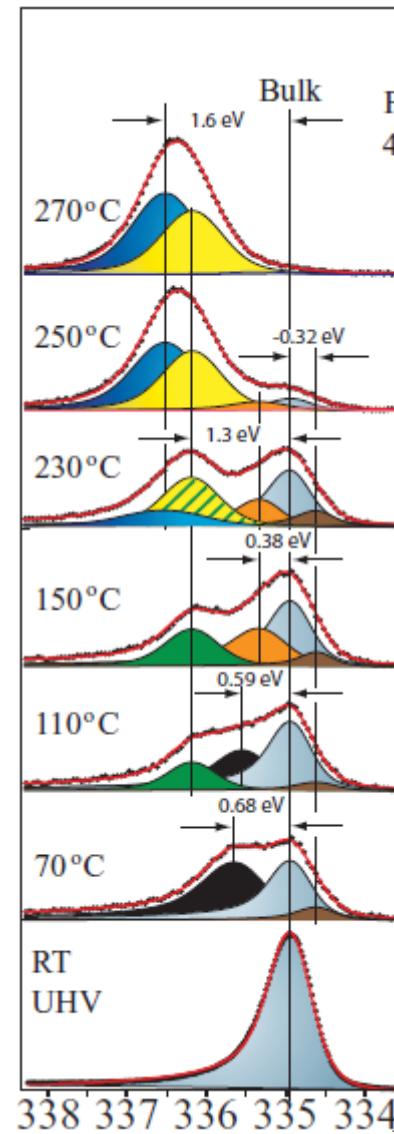
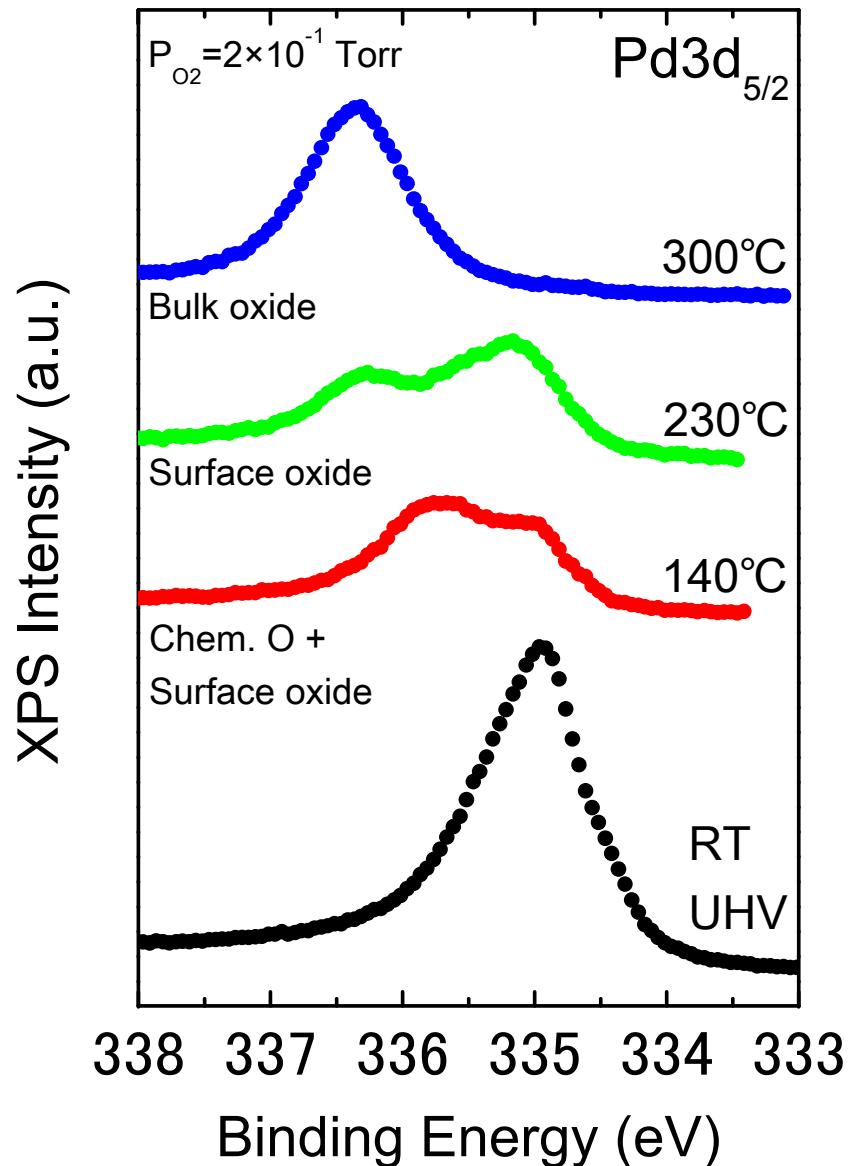
2-stage differential pumping for analyzer
2-stage differential pumping for chamber





NAP-XPS at the Photon Factory

Actual NAP-XP spectra taken at BL-13A with $E_{kin} = 100$ eV



Good agreement with previous results obtained under a similar condition
(Gas: O₂ 0.5 mbar)

(PRB 83, 115440 (2011))

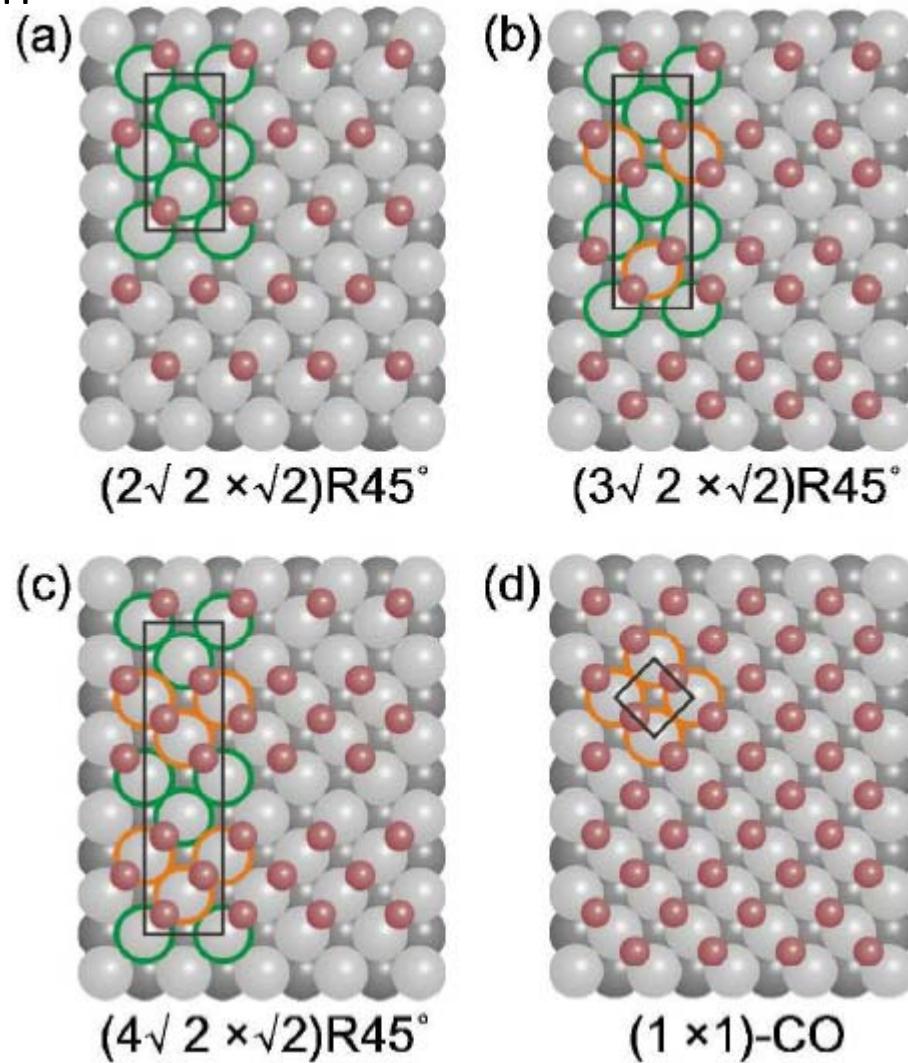
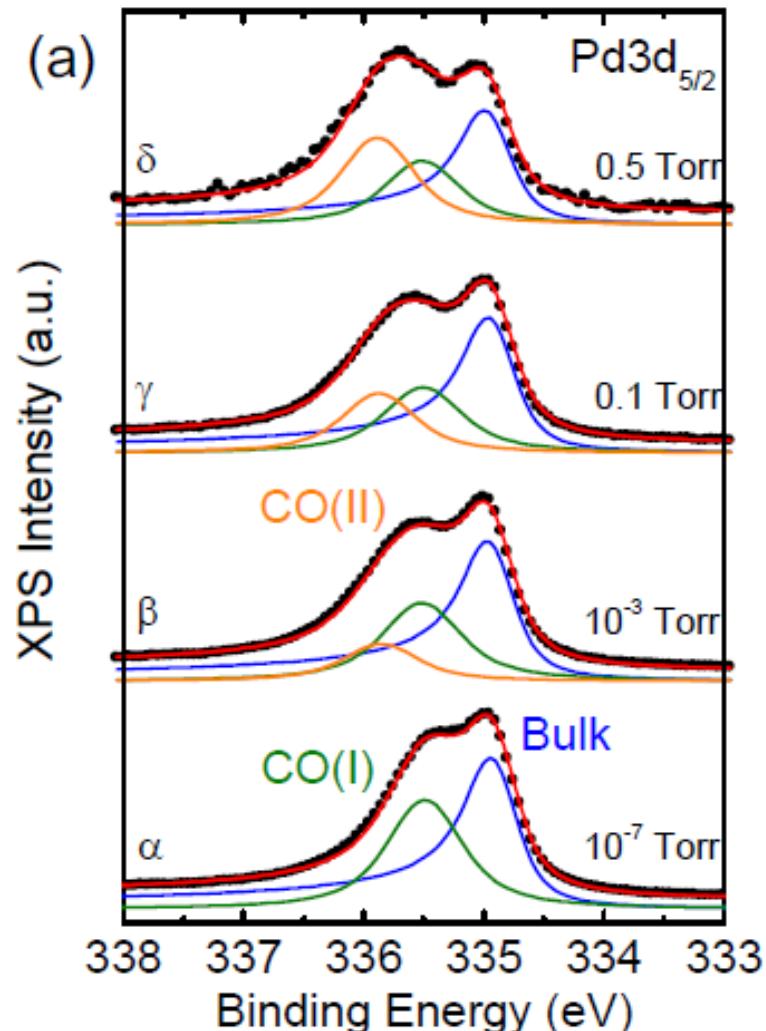
J. Phys. Chem. Lett. 3, 3182 (2012).



NAP-XPS at the Photon Factory

Actual NAP-XP spectra taken at BL-13A with $E_{kin} = 100$ eV

Sample: Pd(100) Gas: up to CO 0.5 Torr



Formation of high-density phases

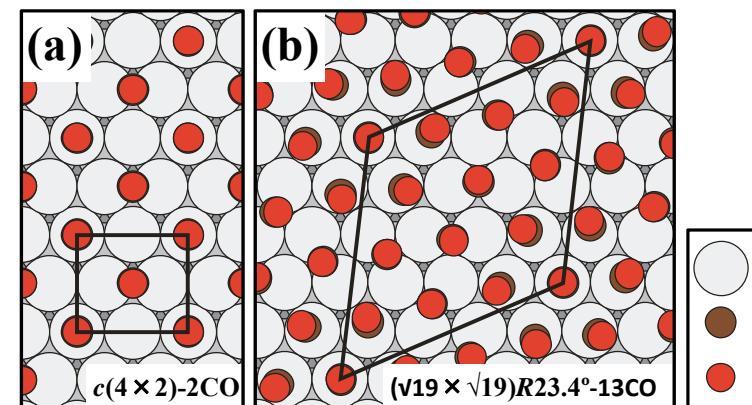
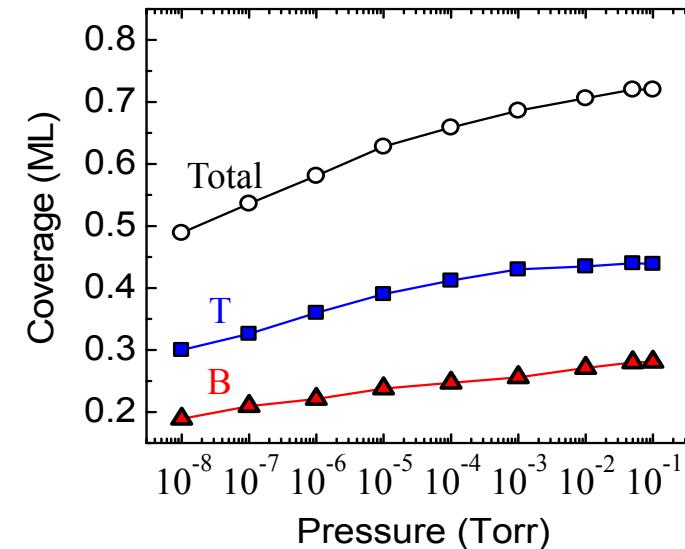
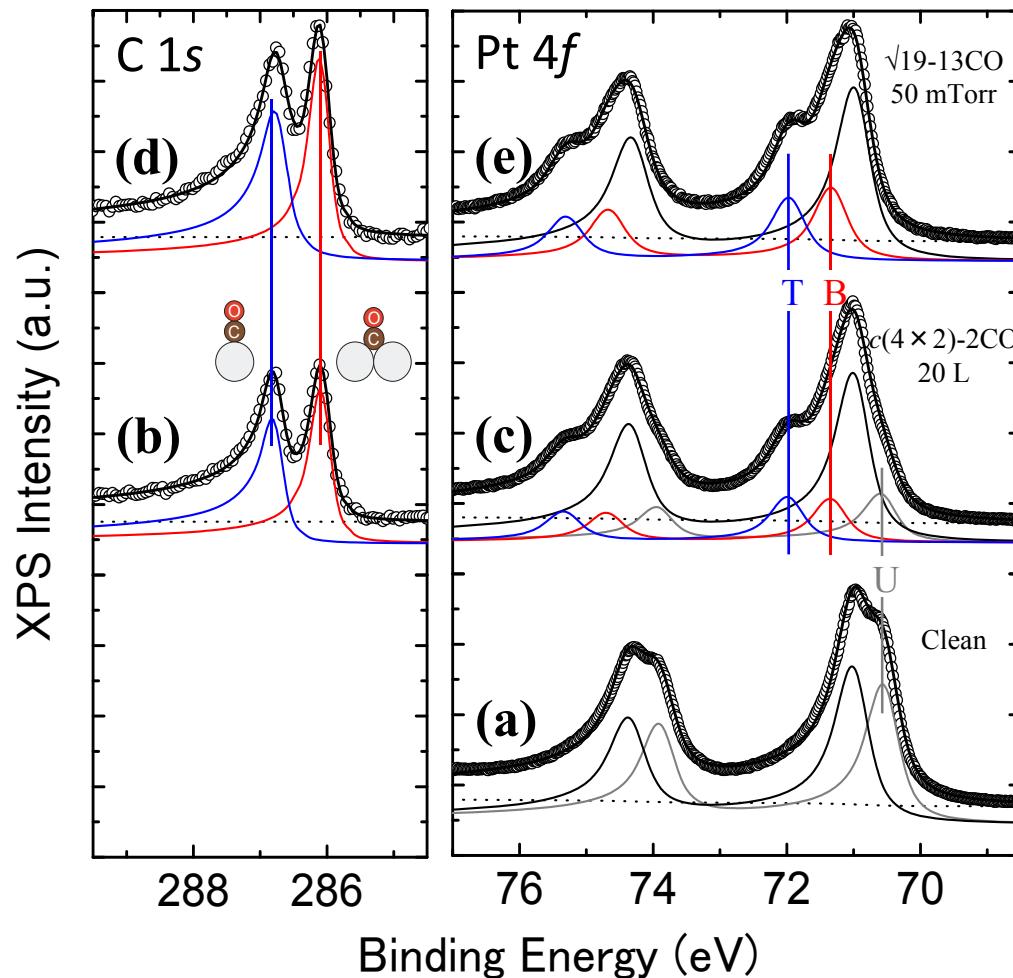
Surf. Sci. **615**, 33 (2013).



NAP-XPS at the Photon Factory

Actual NAP-XP spectra taken at BL-13A with $E_{kin} = 100$ eV

Sample: Pt(111) Gas: CO 10^{-8} – 10^{-1} Torr



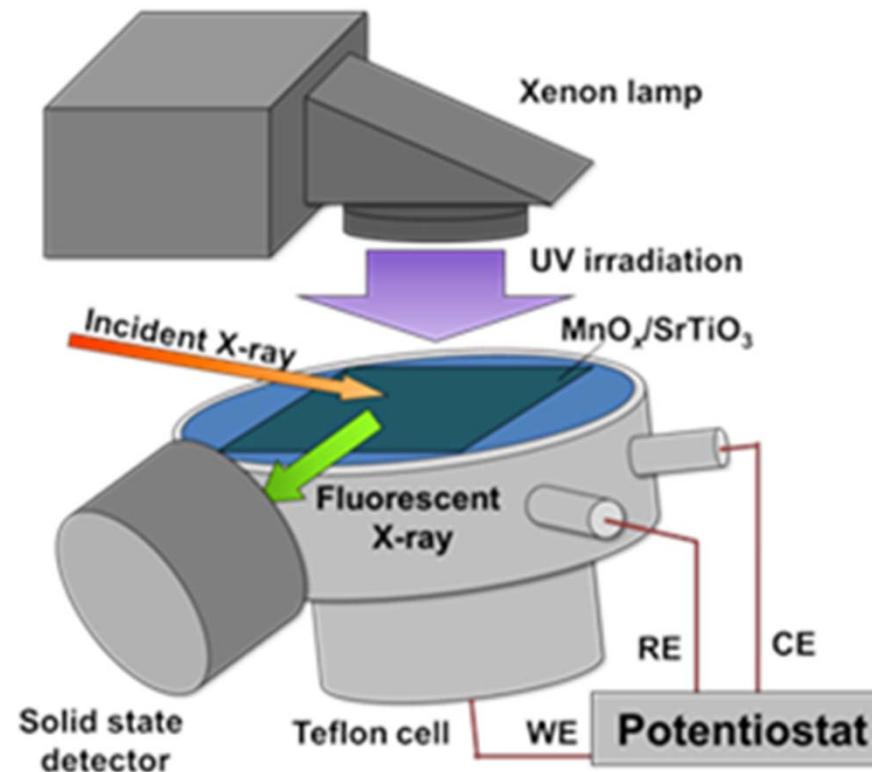
Formation of high-density phases

Phys. Chem. Chem. Phys. **16**, 23564 (2014).



電気化学XAFS

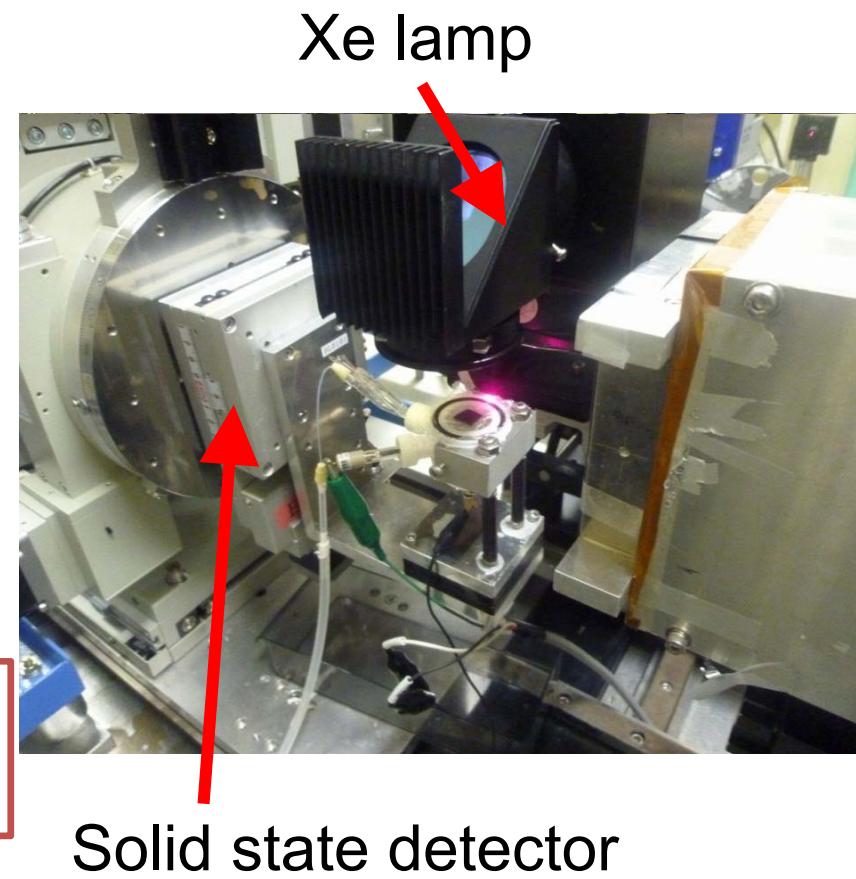
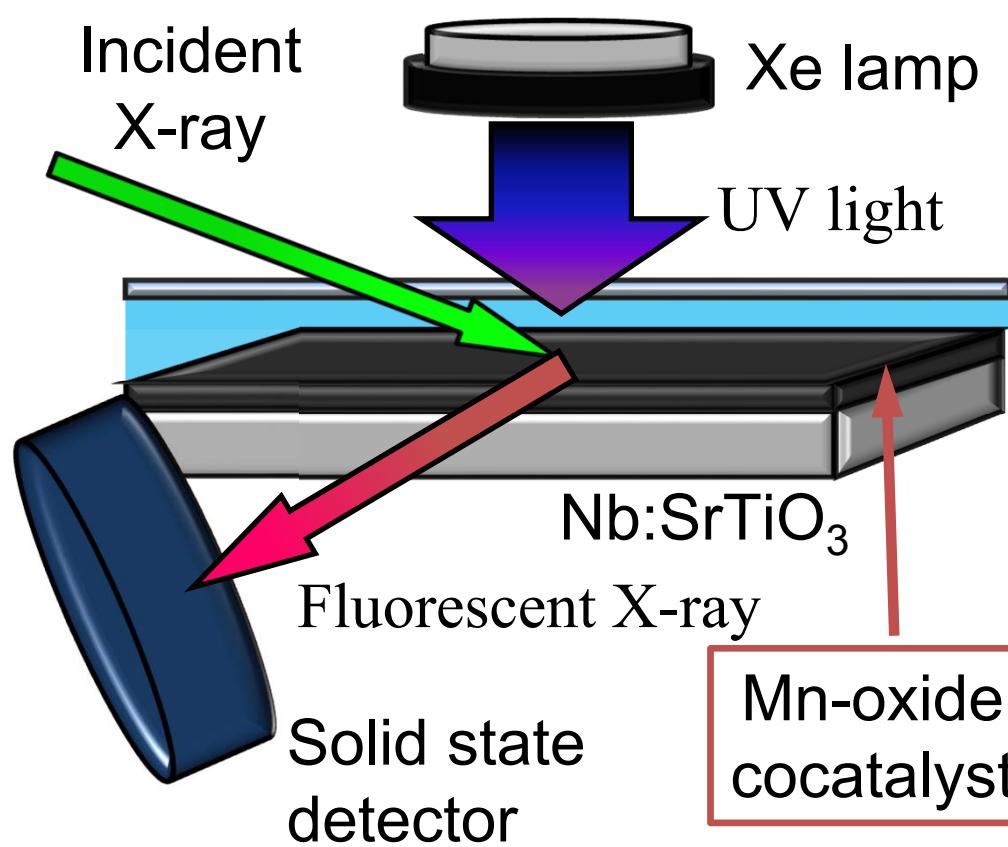
電気化学制御下の試料の蛍光XAFSを
水中の光電極のオペランド観測に応用





電気化学XAFS

電気化学制御下のセルに紫外光を照射

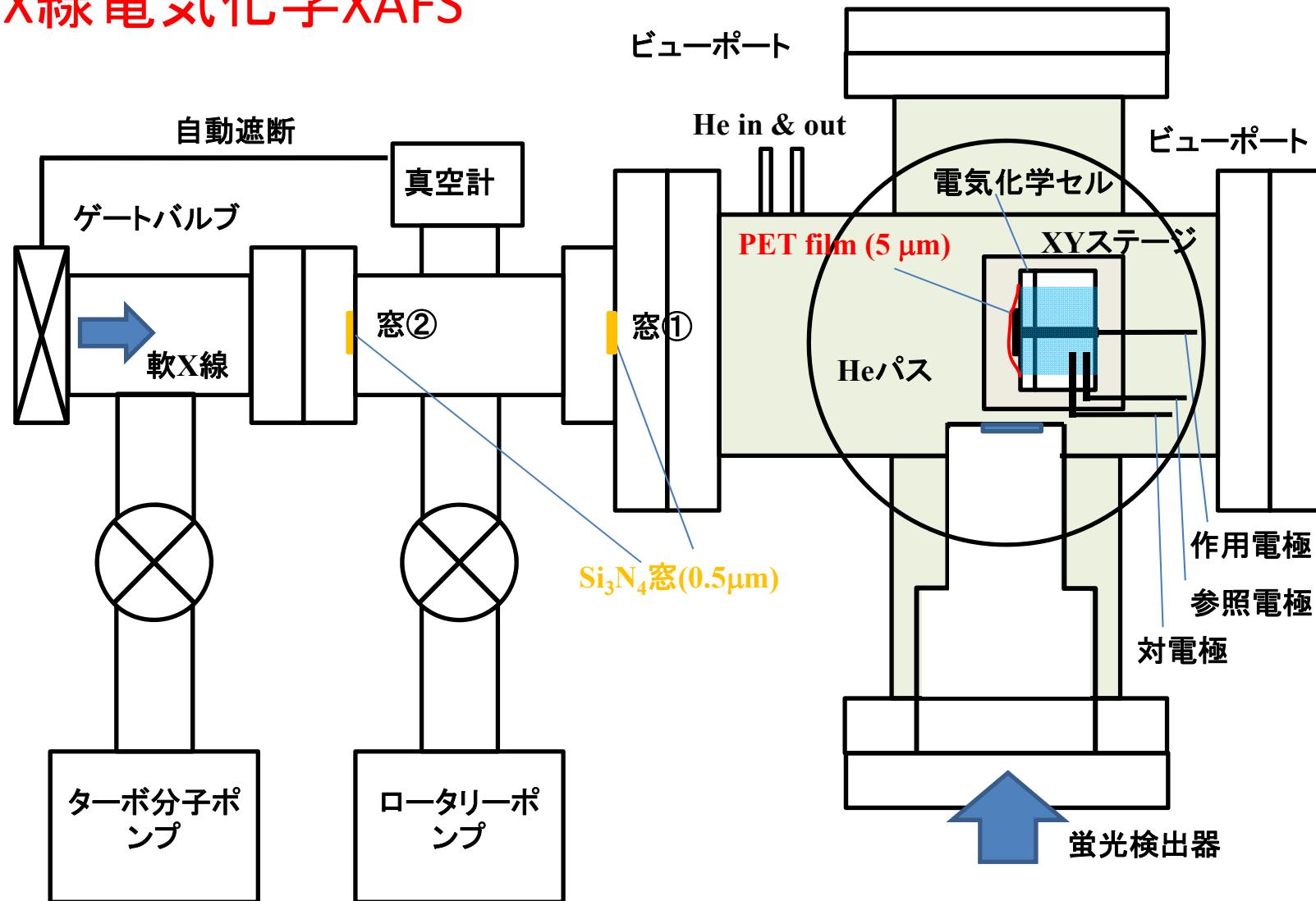


水分解反応時の助触媒の化学状態をその場観測



軟X線電気化学XAFS

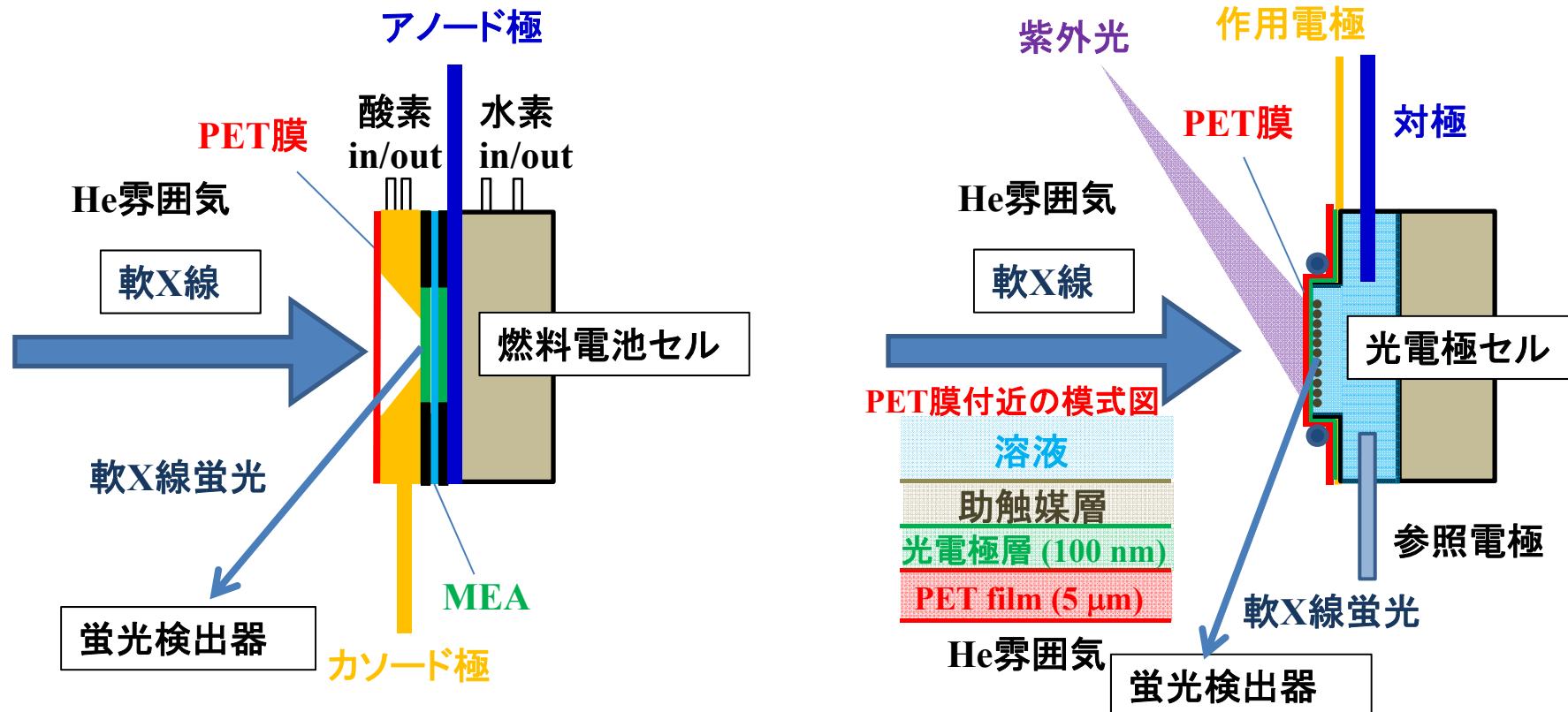
軟X線電気化学XAFS





軟X線電気化学XAFSによるオペランド観測

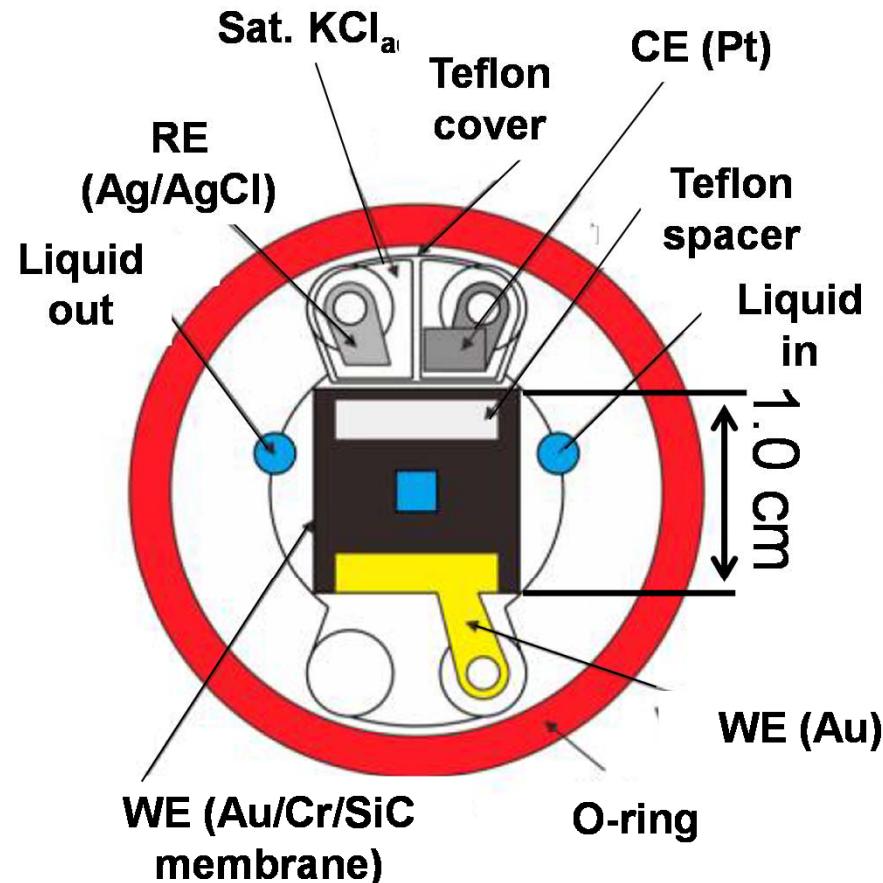
軟X線電気化学XAFSのセルと測定配置



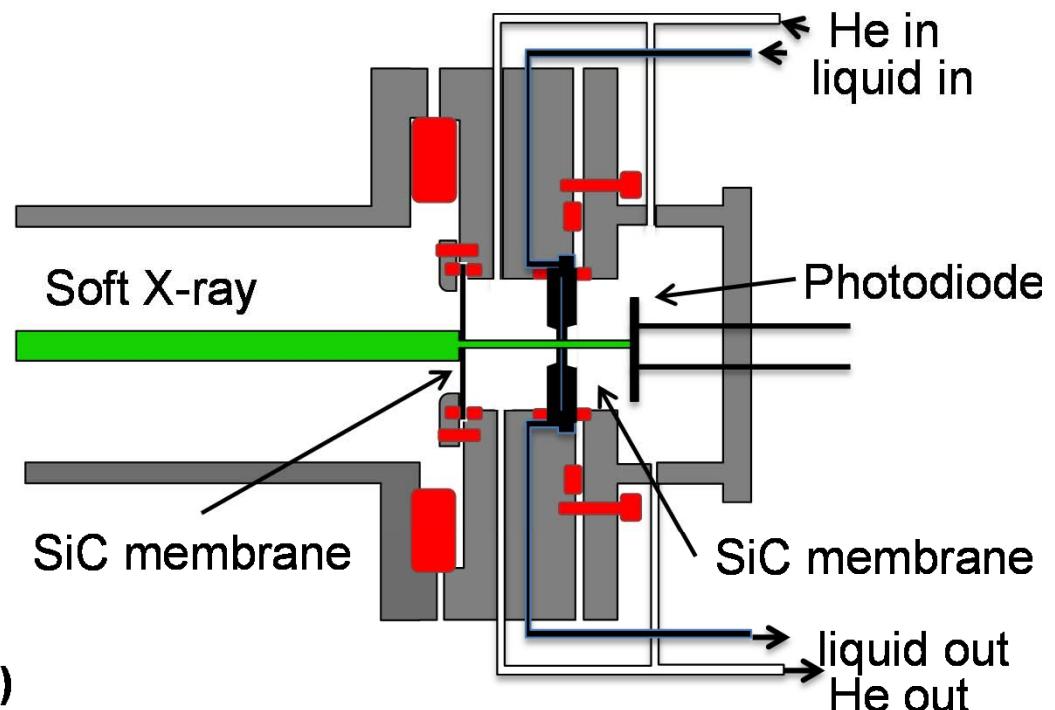


透過型軟X線電気化学XAFS

測定セルの内部



透過法によるXAFS測定

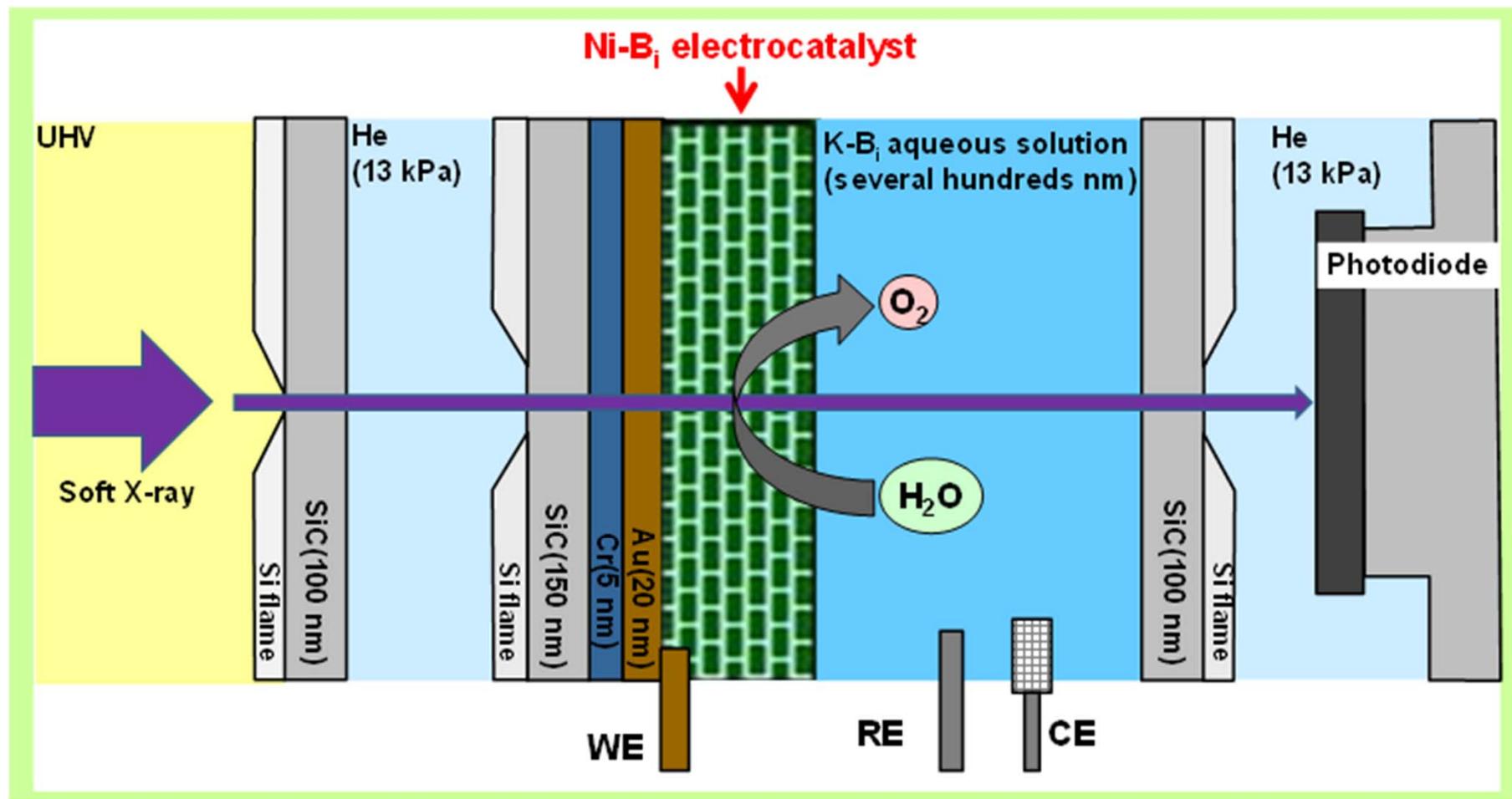


M. Nagasaka, et al. *J. Phys. Chem. C.*, 117, 16343 (2013).

電析した触媒膜のC, N, O端XAFS測定が可能



透過型軟X線電気化学XAFSによる オペランド観測



電極上触媒薄膜のオペランドXAFS測定が可能



目次

背景

軟X線オペランド観測手法

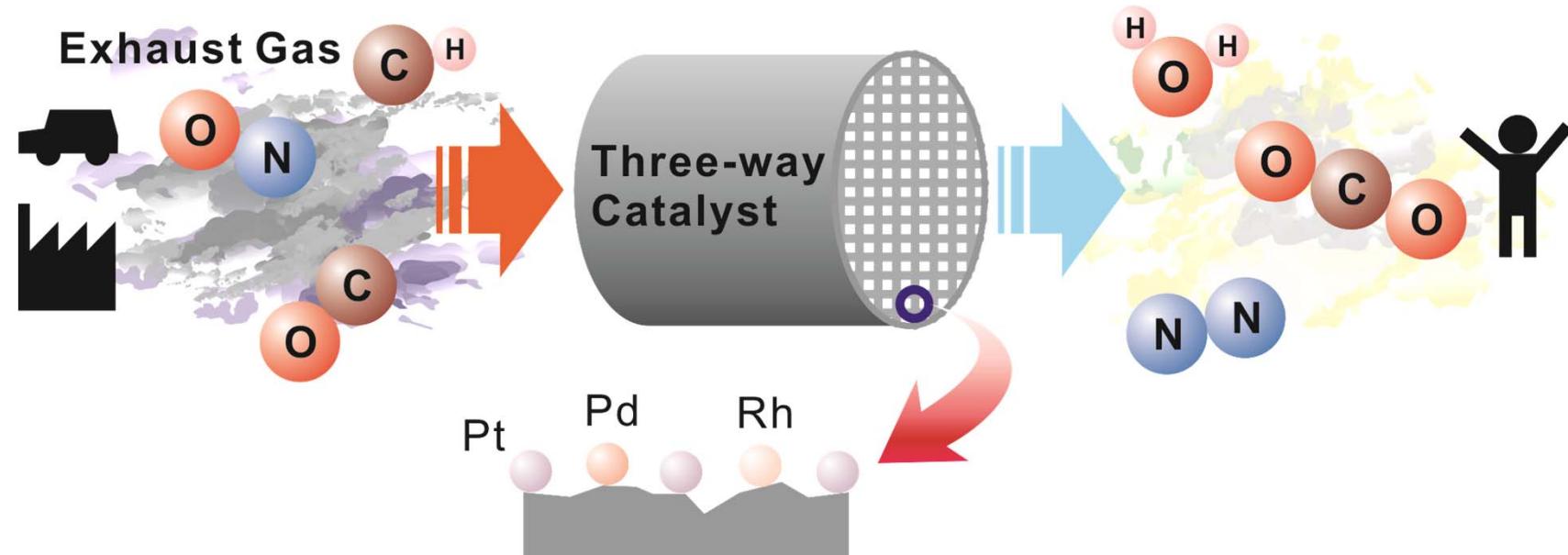
触媒が活性になったときに見えるもの

NAP-XPSによる排気ガス浄化触媒

電気化学XAFSによる水分解触媒



CO oxidation on Pt-group metal surfaces



Ru 44	Rh 45	Pd 46
Os 76	Ir 77	Pt 78



Active Surface for CO oxidation on Pd

Previous results for Pd surfaces



Ultra High Vacuum; 10^{-9} Torr
Near Ambient Pressure; $>10^{-2}$ Torr

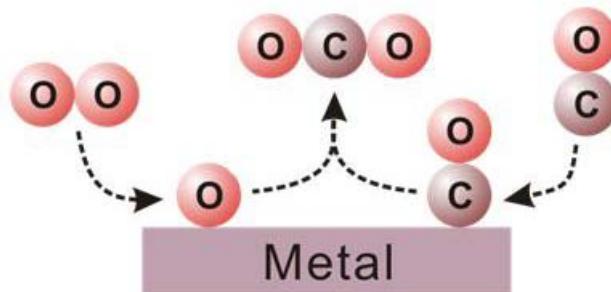
① Chemisorbed O/Metal

MB Ertl *et al.*, *J. Chem. Phys.* **1978**, *69*, 1267.

XPS Nakai *et al.*, *J. Chem. Phys.* **2006**, *124*, 224712.

AP-Mass Chen *et al.*, *Surf. Sci.* **2007** *601*, 5326.

PM-IRAS Gao *et al.*, *Surf. Sci.* **2009**, *603*, 65.



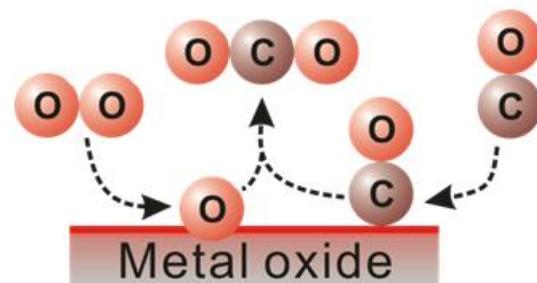
Langmuir-Hinshelwood

② Surface Oxide

SXRD van Rijn *et al.*, *Phys. Chem. Chem. Phys.* **2011**, *13*, 13167.

SXRD Gustafson *et al.*, *Phys. Rev. B* **2008**, *78*, 045423.

HP-STM Hendriksen *et al.*, *Surf. Sci.* **2004**, *552*, 229.



Mars-van Krevelen

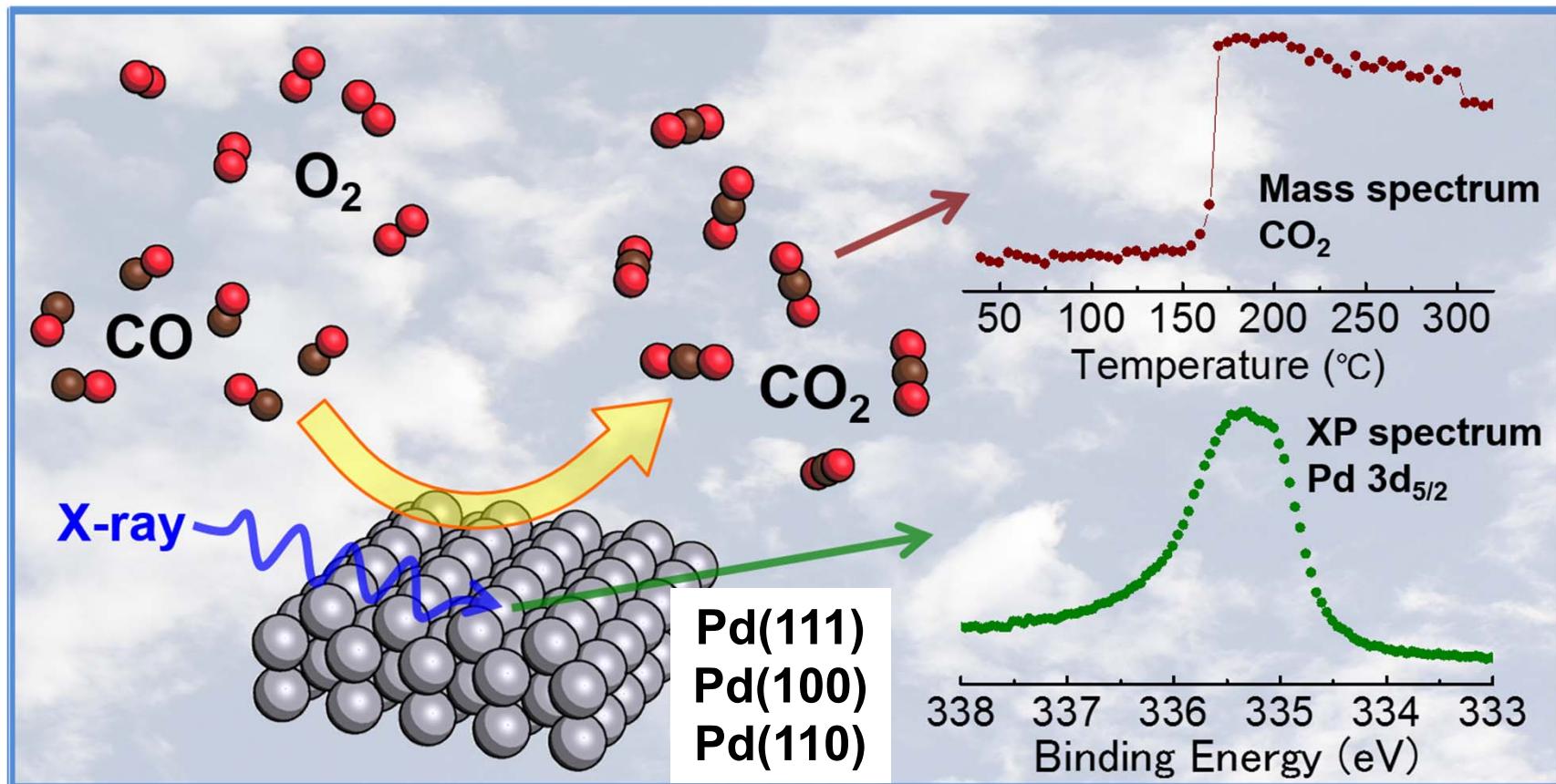


In-situ observation using NAP-XPS

Active phase for CO oxidation
on three Pd surfaces?

Oxygen-rich condition

$$P_{O_2} = 2 \times 10^{-1} \text{ Torr}$$
$$P_{CO} = 2 \times 10^{-2} \text{ Torr}$$





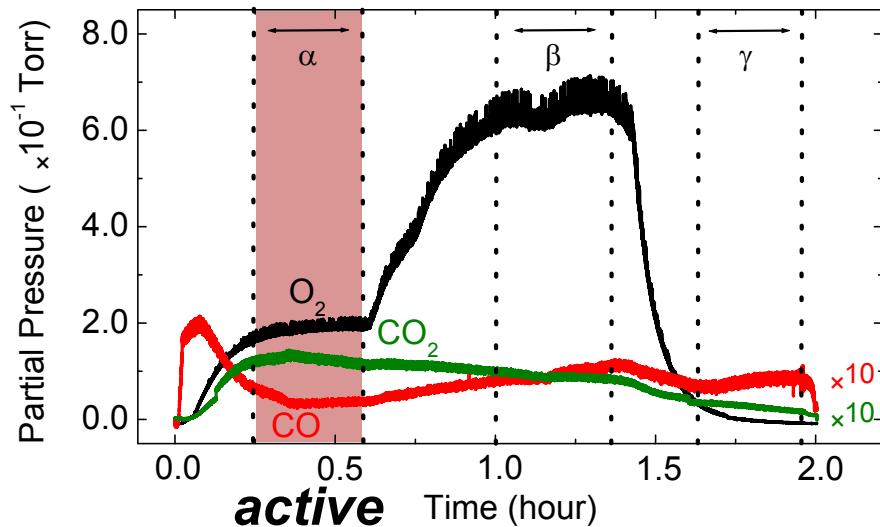
CO oxidation on Pd(111)

Oxygen-rich condition

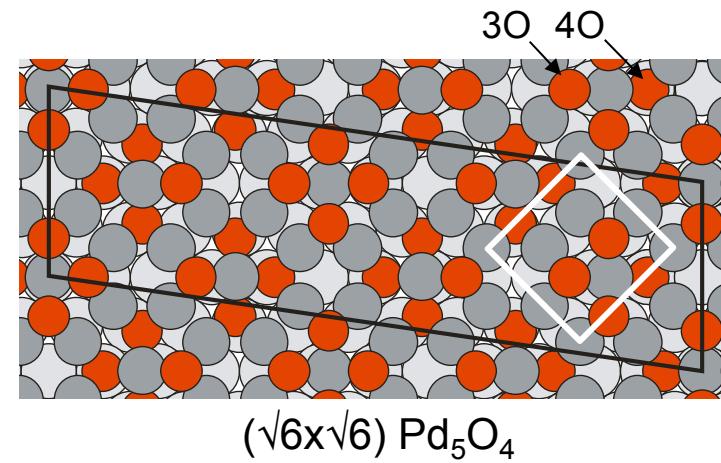
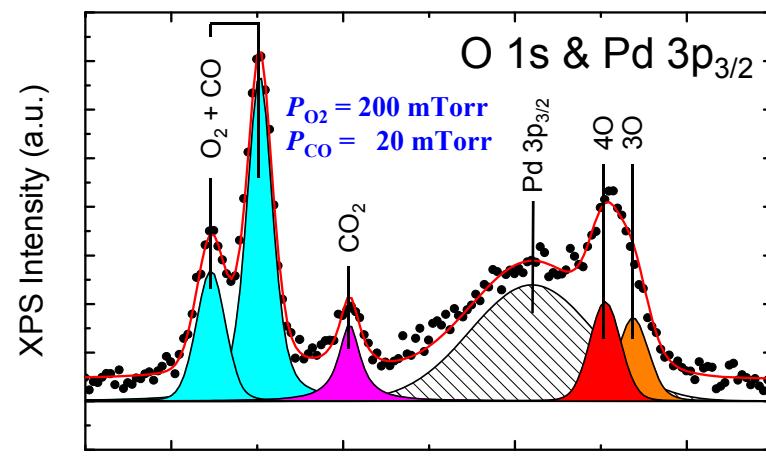
$$\begin{aligned}P_{\text{O}_2} &= 2 \times 10^{-1} \text{ Torr} \\P_{\text{CO}} &= 2 \times 10^{-2} \text{ Torr}\end{aligned}$$

Temperature: 300°C

Partial Pressure

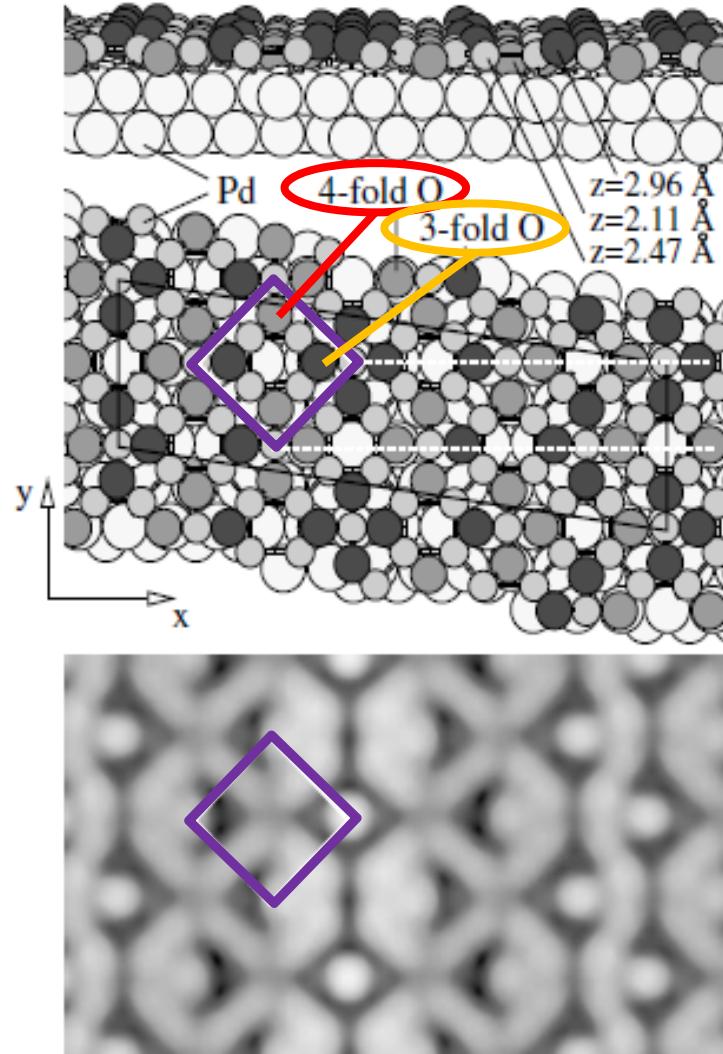


NAP-XPS





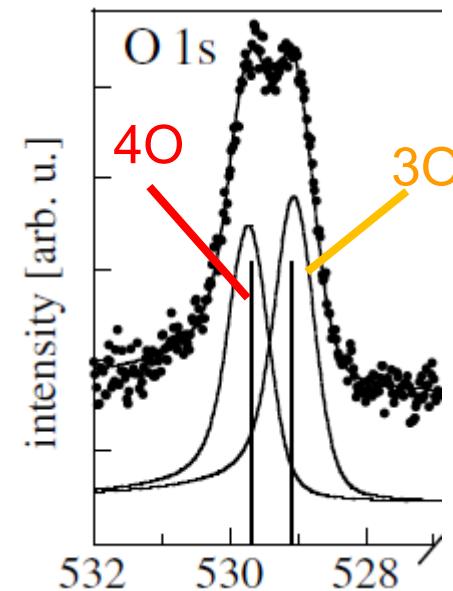
Structure of surface oxide on Pd(111)



Surface oxide: $(\sqrt{6} \times \sqrt{6})\text{Pd}_5\text{O}_4$

3O \Rightarrow 3-fold coordinated O

4O \Rightarrow 4-fold coordinated O

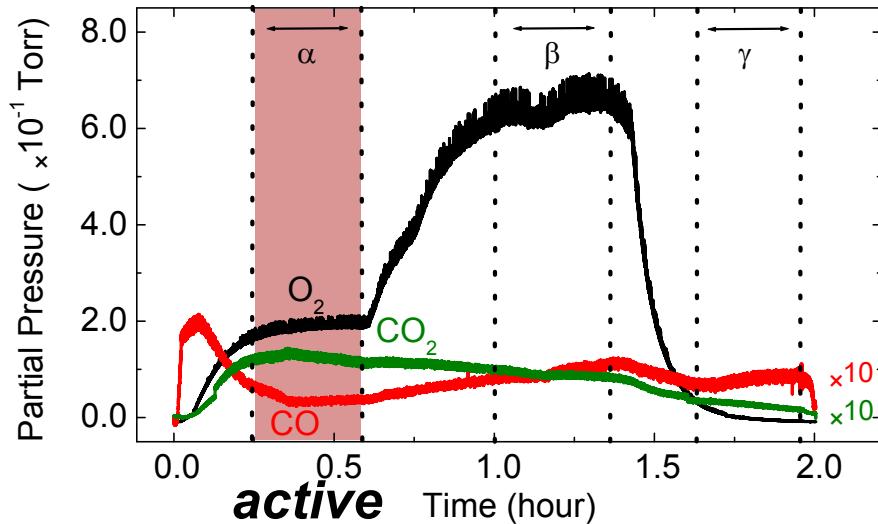


E. Lundgren et al., *Phys. Rev. Lett.*, **88**, 246103, (2002).

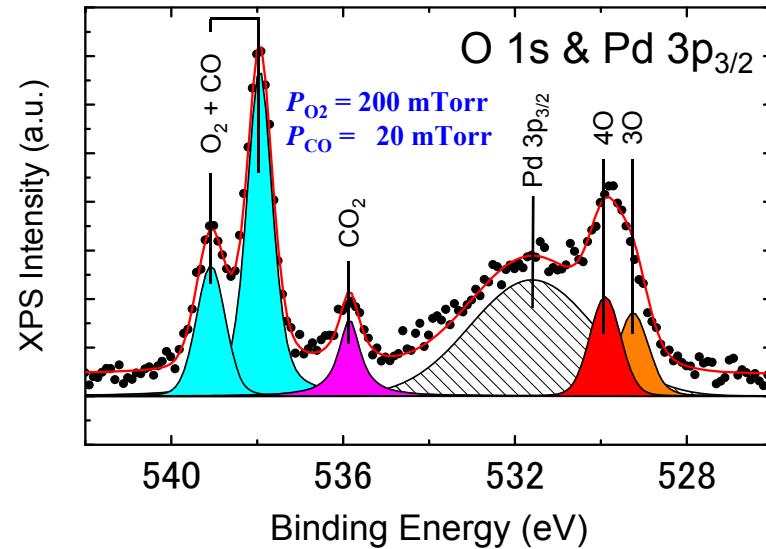


CO oxidation on Pd(111)

Partial Pressure



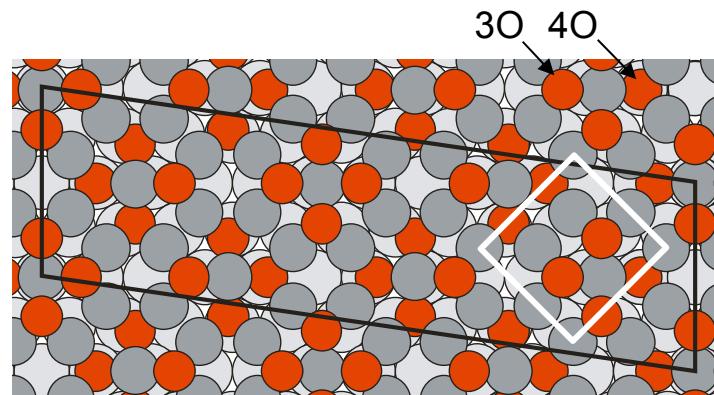
NAP-XPS



$(\sqrt{6} \times \sqrt{6}) Pd_5O_4$ surface oxide

E. Lundgren et al., *Phys. Rev. Lett.*, **88**, 246103, (2002).

dominant phase



$(\sqrt{6} \times \sqrt{6}) Pd_5O_4$

J. Phys. Chem. C **116**, 18691 (2012).



CO oxidation on Pd(100)

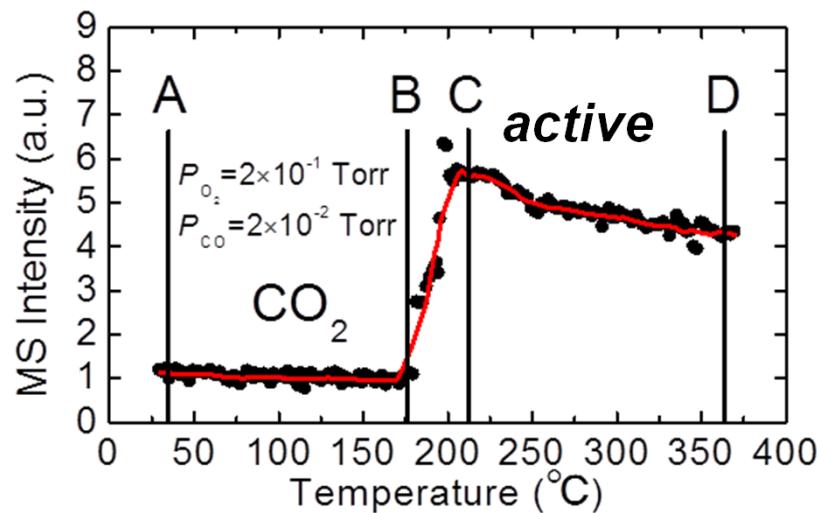
Oxygen-rich condition

$$P_{O_2} = 2 \times 10^{-1} \text{ Torr}$$

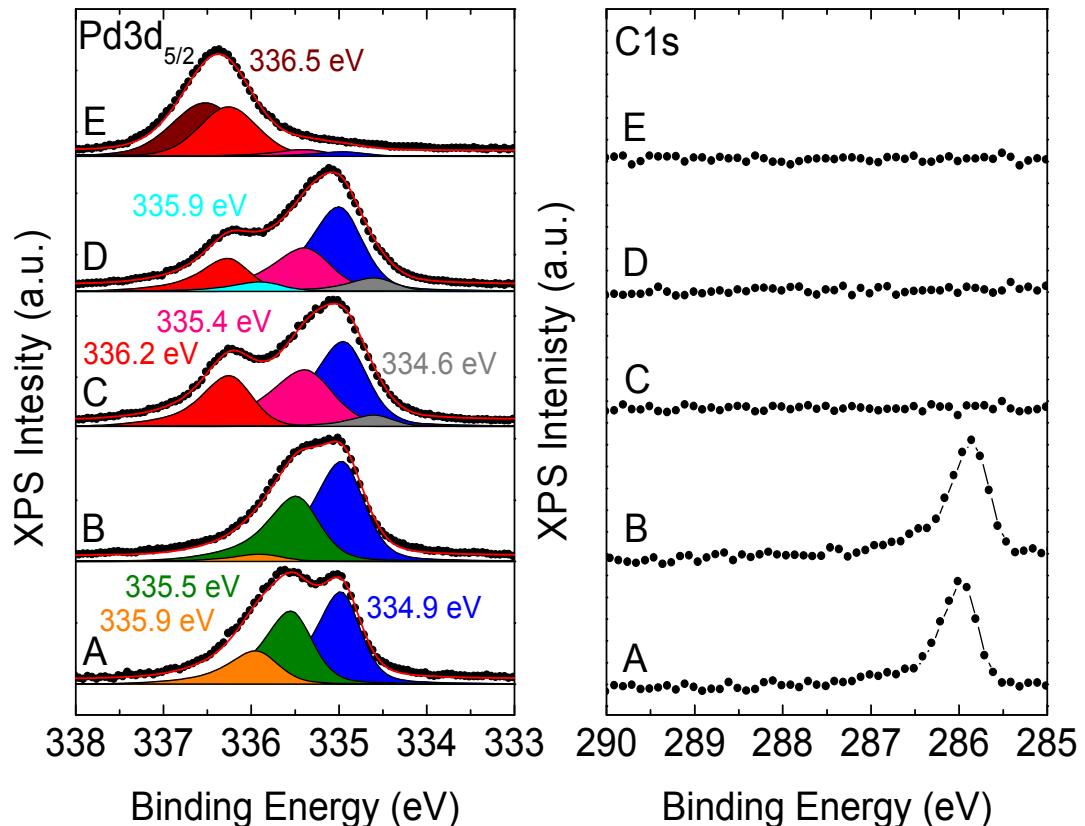
$$P_{CO} = 2 \times 10^{-2} \text{ Torr}$$

increasing temperature

CO_2 intensity



NAP-XPS



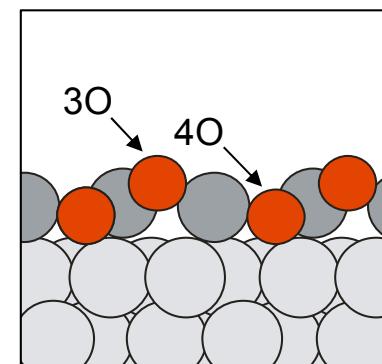
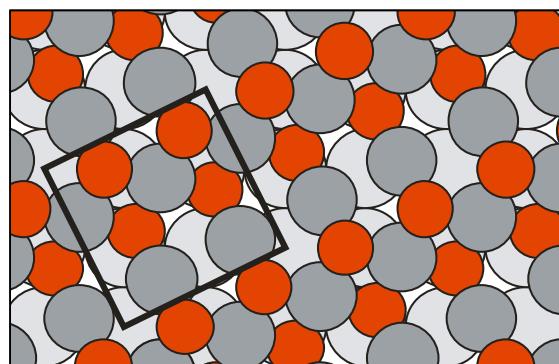
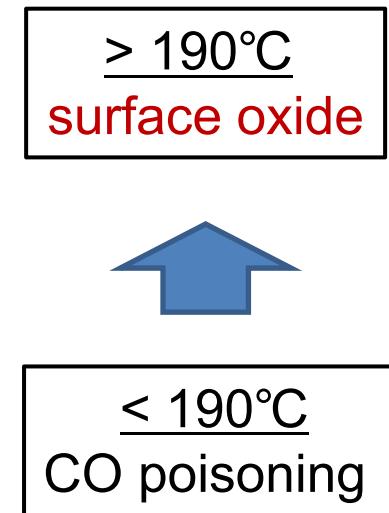
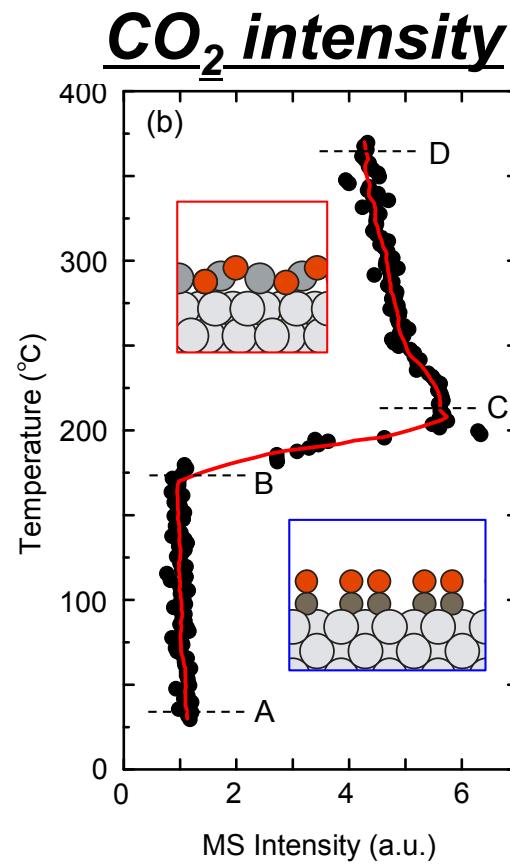
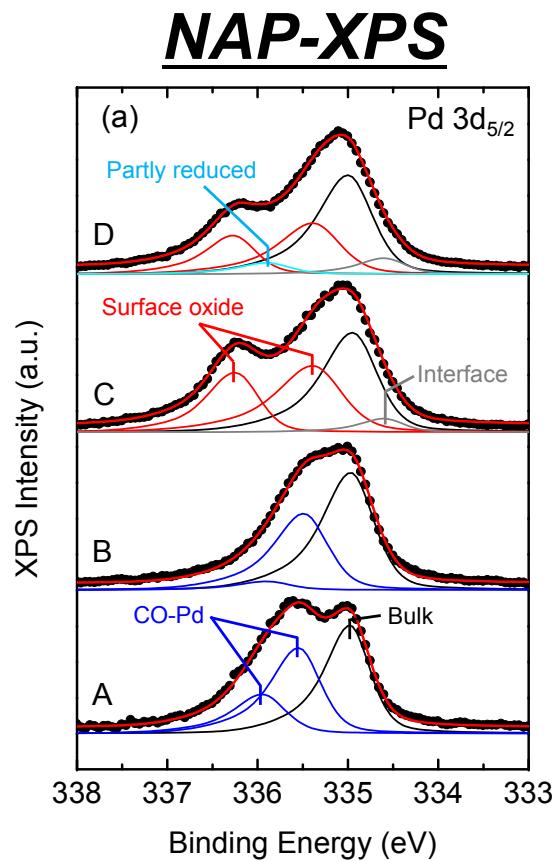
$< 190^{\circ}\text{C}$
 CO poisoning



$> 190^{\circ}\text{C}$
 surface oxide



CO oxidation on Pd(100)



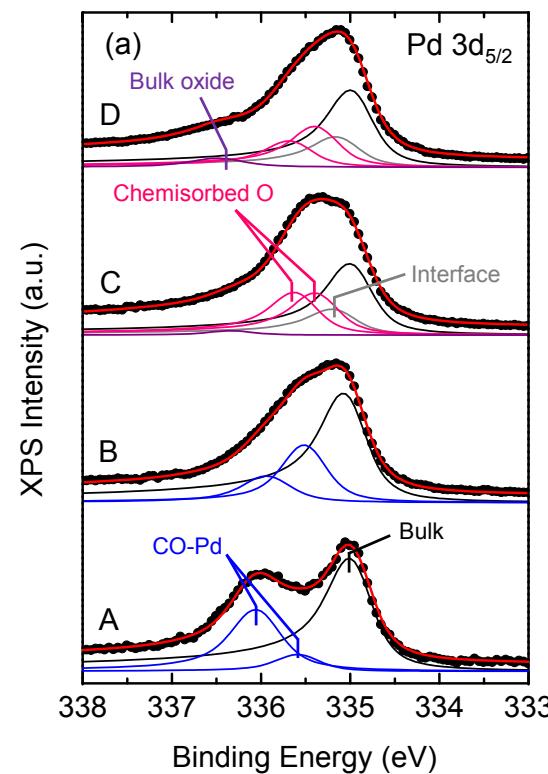
$(\sqrt{5} \times \sqrt{5})\text{R}27^\circ$
surface oxide

J. Phys. Chem. Lett. **3**, 3182 (2012).

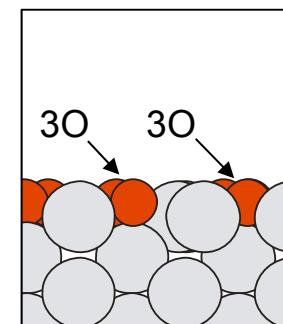
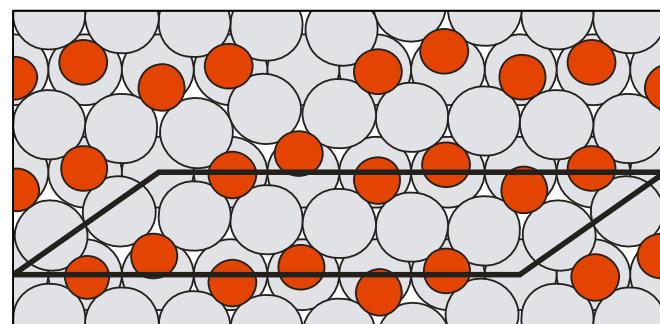
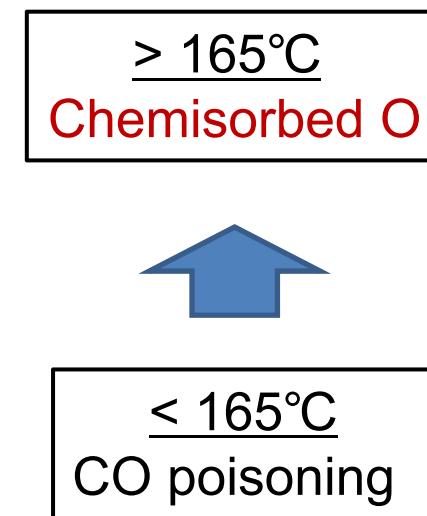
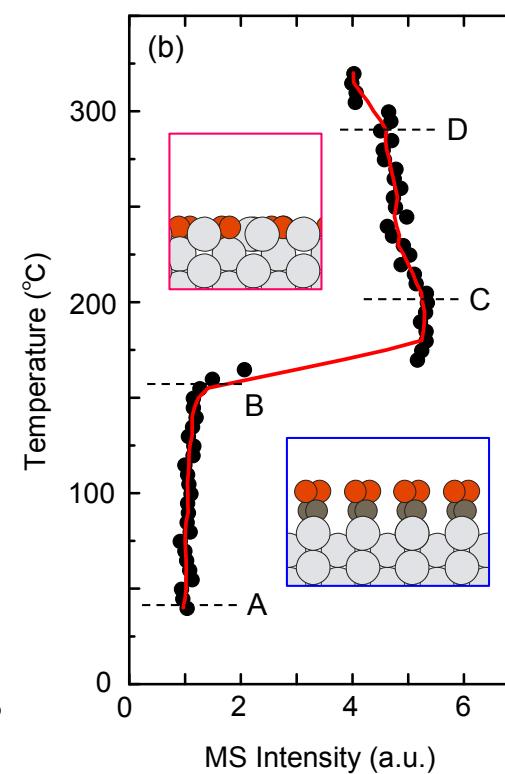


CO oxidation on Pd(110)

NAP-XPS



CO₂ intensity



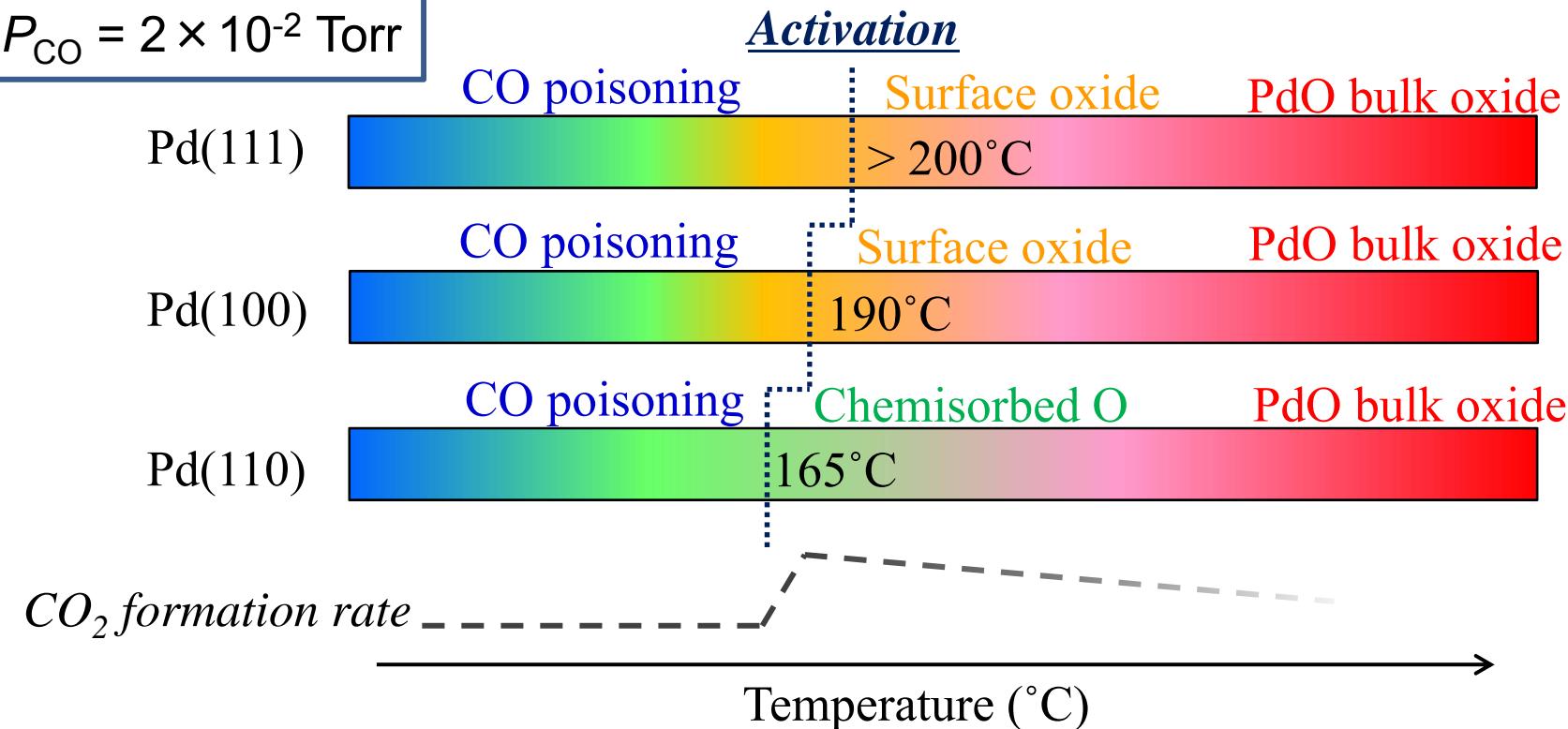
$(7 \times \sqrt{3})$
Chemisorbed O



CO oxidation on Pd surfaces

$$P_{\text{O}_2} = 2 \times 10^{-1} \text{ Torr}$$

$$P_{\text{CO}} = 2 \times 10^{-2} \text{ Torr}$$



Active Phases for CO oxidation on Pd

Both **Surface oxide** and **Chem-O** can be reactive depending on surface orientation.

- J. Phys. Chem. C* **116**, 18691 (2012).
- J. Phys. Chem. Lett.* **3**, 3182 (2012).
- J. Phys. Chem. C* **117**, 20617 (2013).



Surface oxide and Chem-O

High-density oxygen are accommodated in the active phases in common:

0.8 ML

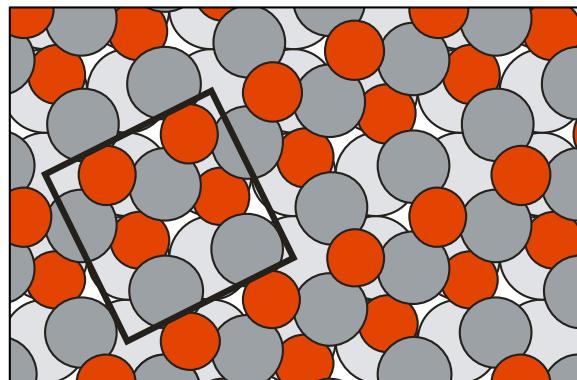
1.0 ML

0.86–0.89 ML

$\sqrt{6}$ surface oxide/Pd(111)

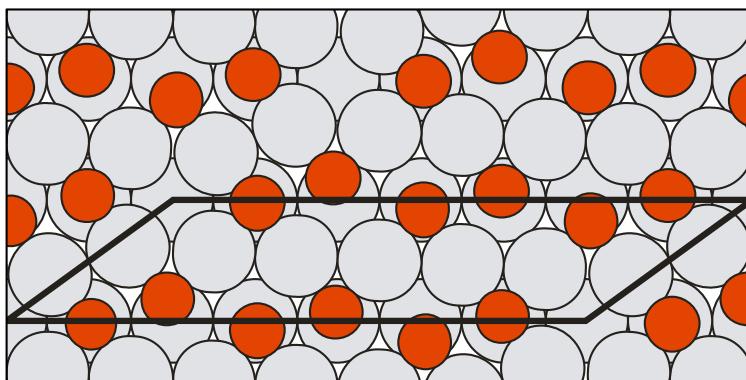
$\sqrt{5}$ surface oxide/Pd(100)

Chemisorbed-O/Pd(110)



Pd(100)

Surface oxide
O-M-O tri-layer



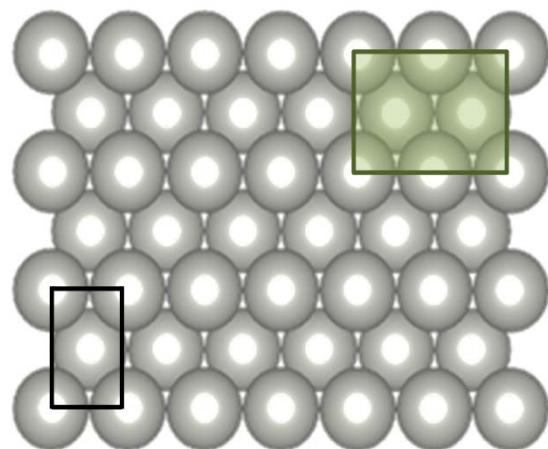
Pd(110)

Chemisorbed-O
O-M-O planer layer



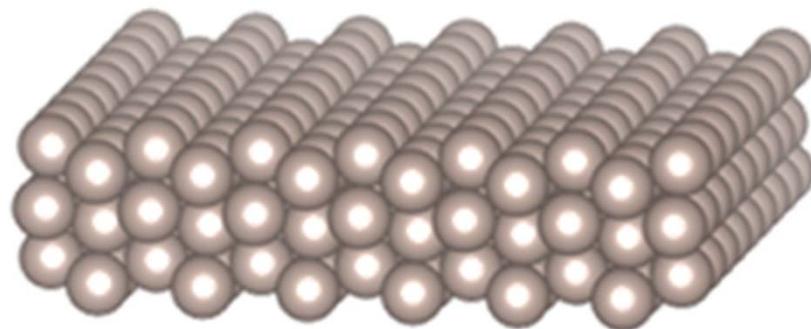
In-situ Observation using AP-XPS

CO oxidation on Ru(10 $\bar{1}$ 0)
under near AP conditions



Pd(110)

Ru	Rh	Pd
44	45	46
Os	Ir	Pt
76	77	78

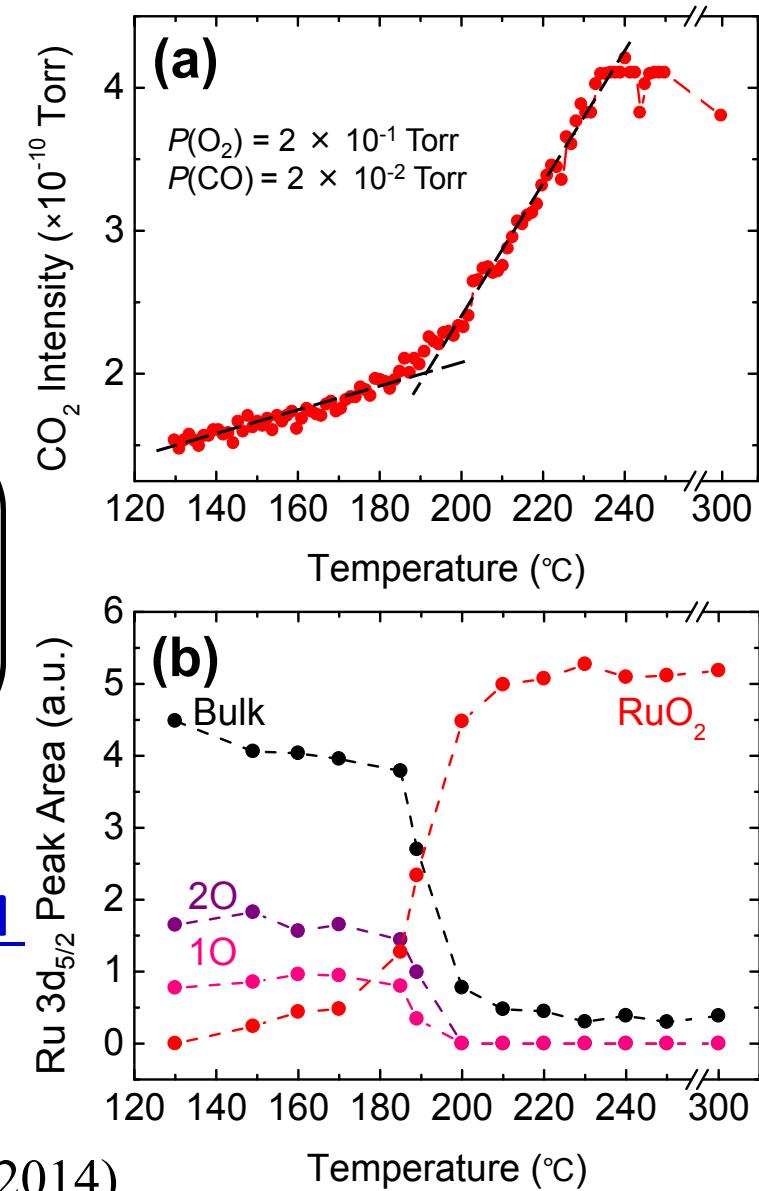
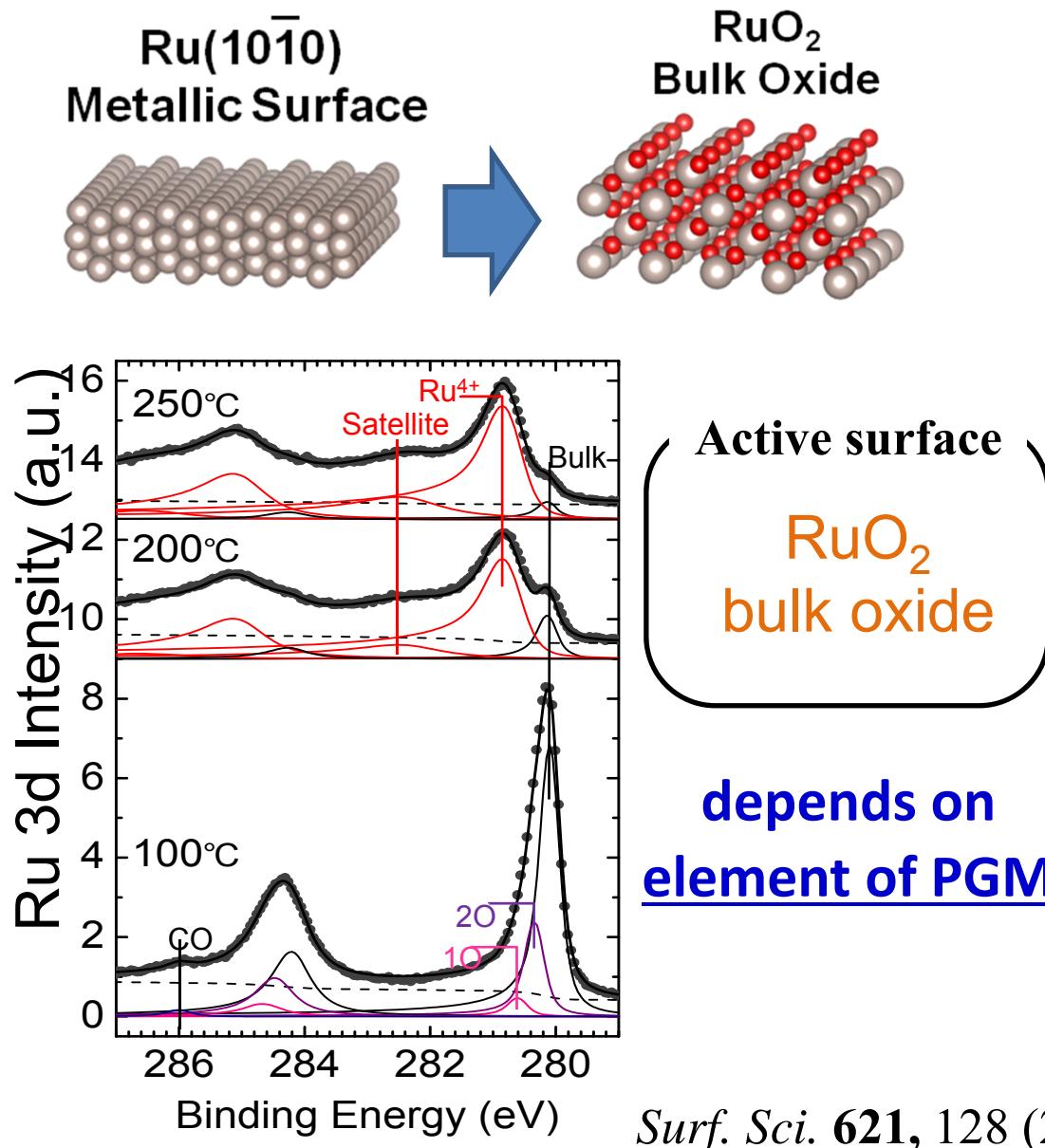


Ru(10 $\bar{1}$ 0)

Similar ridge & trough surface structure



CO oxidation on Ru(10 $\bar{1}$ 0)



PGM上のCO酸化反応のまとめ

CO酸化反応に活性な触媒表面

- ・酸化物
- ・化学吸着酸素/金属の両方が活性になりうる
- ・高密度酸素相が重要

Pt-group metals (PGM)

oxide	Ru	Rh	Pd
	44	45	46
Os		Ir	Pt
	76	77	78

Chem-O/metal



目次

背景

軟X線オペランド観測手法

触媒が活性になったときに見えるもの

NAP-XPSによる排気ガス浄化触媒

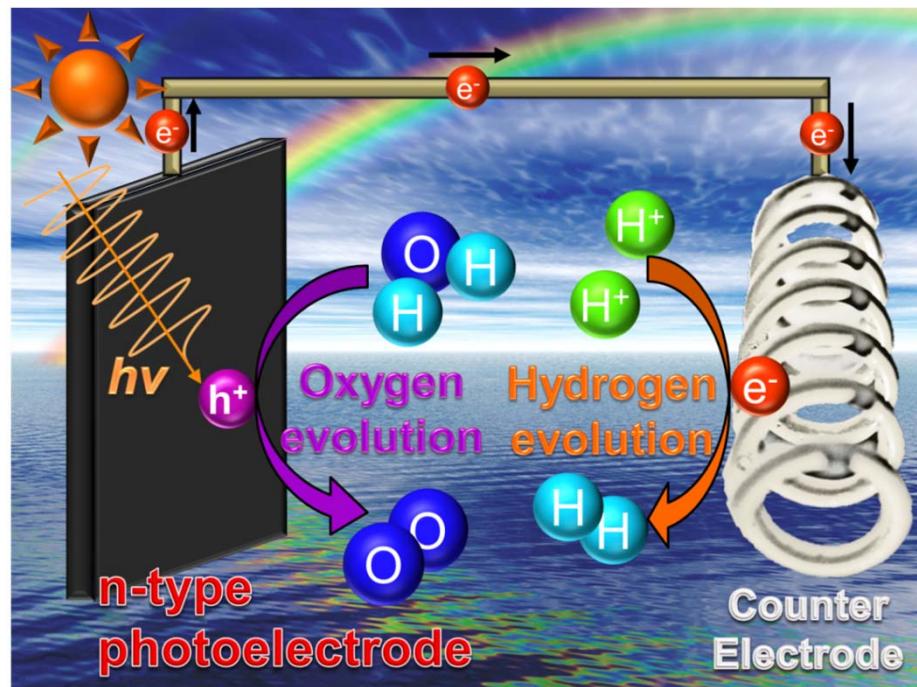
電気化学XAFSによる水分解触媒



水分解光電極

持続的エネルギー供給を実現するエネルギー変換

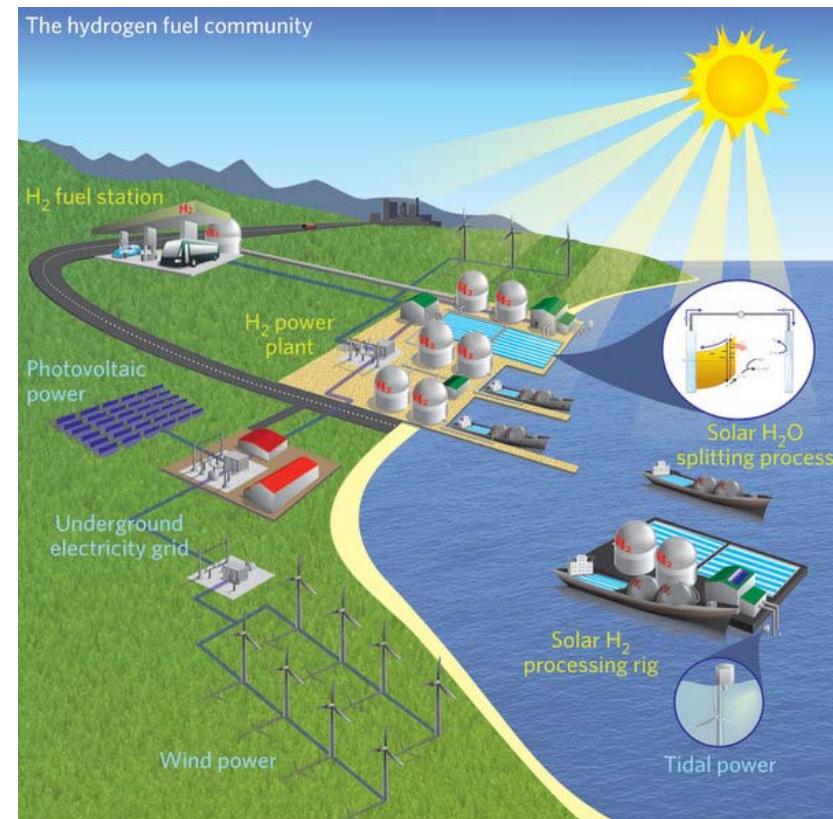
半導体を電極として使用



太陽光と水から水素を製造

A. Fujishima, K. Honda, *Nature* 1972, 238, 37.

水分解の効率が低く、実用化のためにさらなる高効率化が必要



水素を燃料とした循環型社会

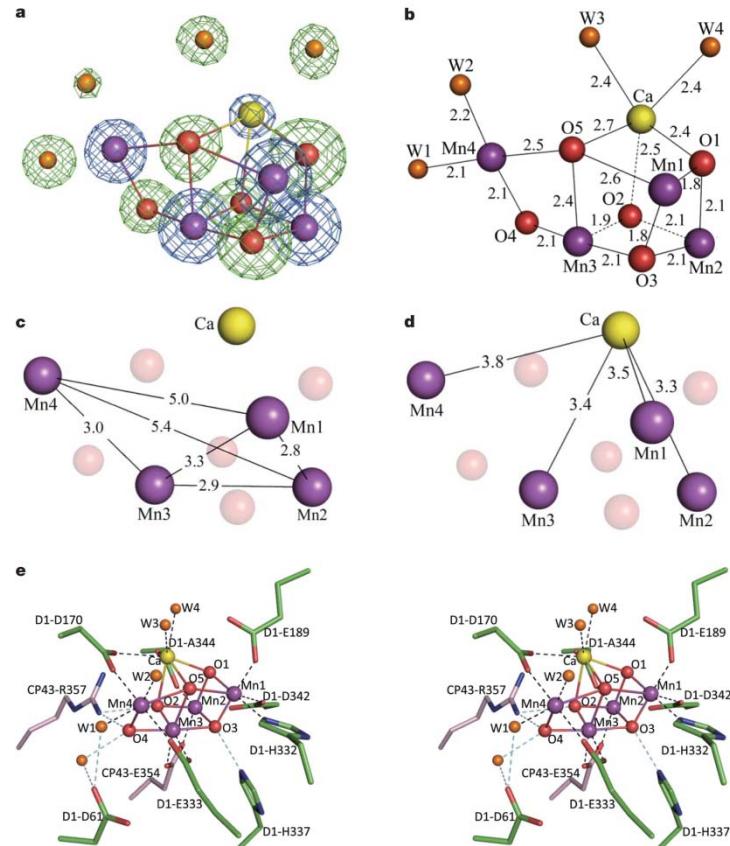
Y. Tachibana et al., *Nat. photonics* 2012, 6, 511.



酸素生成触媒としてのマンガン酸化物

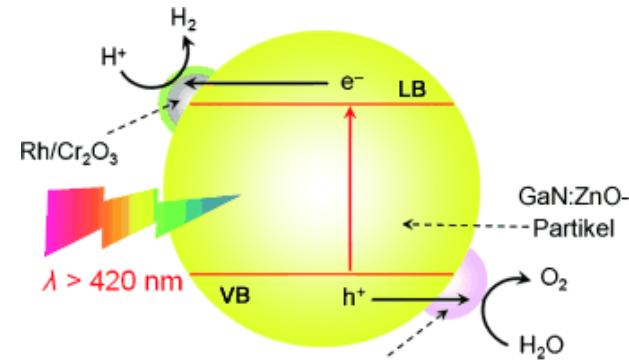
マンガン酸化物は酸素生成の触媒として機能

自然界における 酸素生成中心

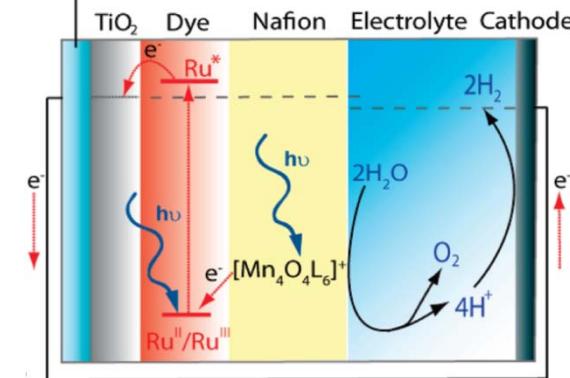


Y. Umeta et al., *Nature* 2011, 473, 55.

光触媒や光電極系における 酸素生成助触媒



K. Maeda et al., *Angew. Chem. Int. Ed.* 2010, 122, 4190.
Conductive glass

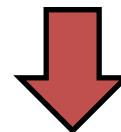


R. Brimblecombe et al., *J. Am. Chem. Soc.* 2010, 132, 2892.

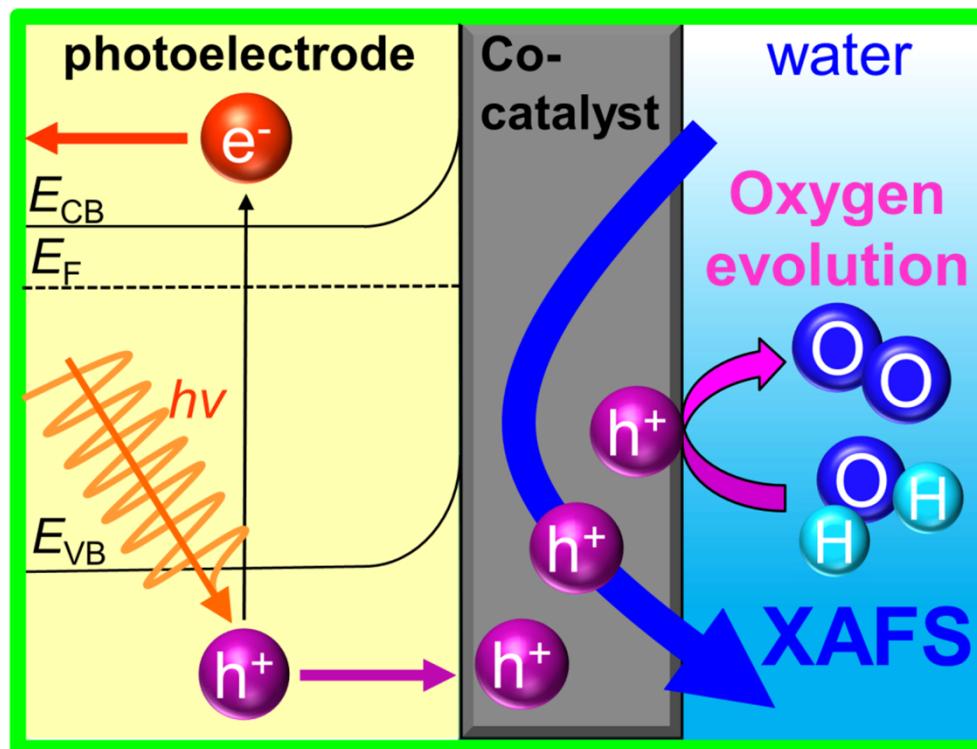


酸素生成触媒としてのマンガン酸化物

水分解反応時の光電極上の助触媒の化学状態を
in-situ電気化学XAFS法によって測定



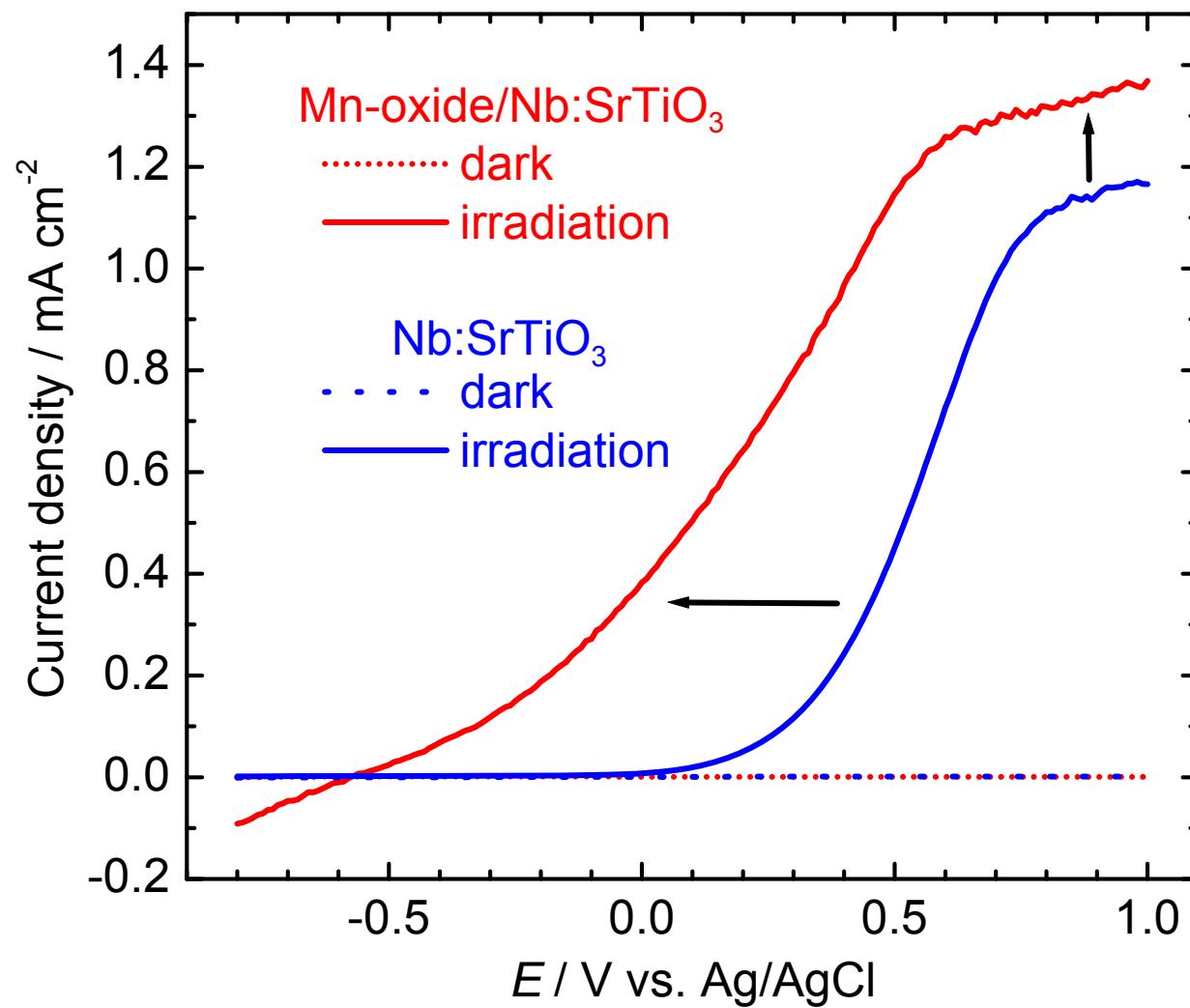
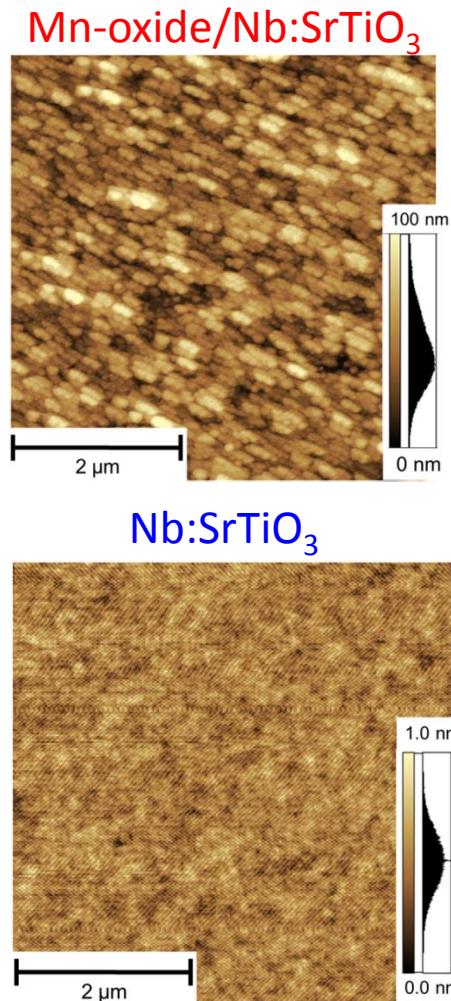
実作動条件下における助触媒の電子状態から
助触媒への励起ホール移動と光電極活性の相関





Mn-oxide/Nb:SrTiO₃光電極の電流-電位曲線

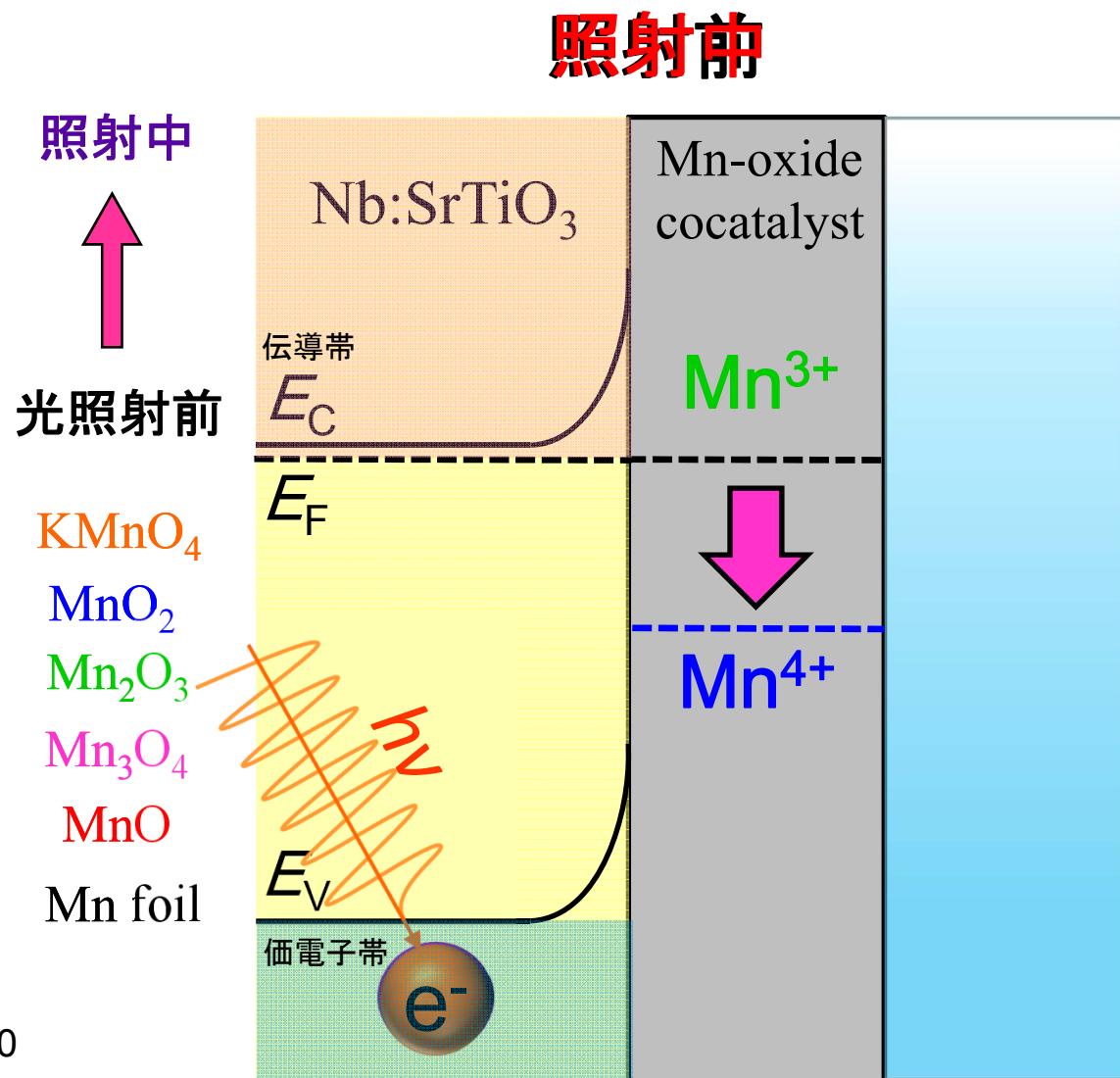
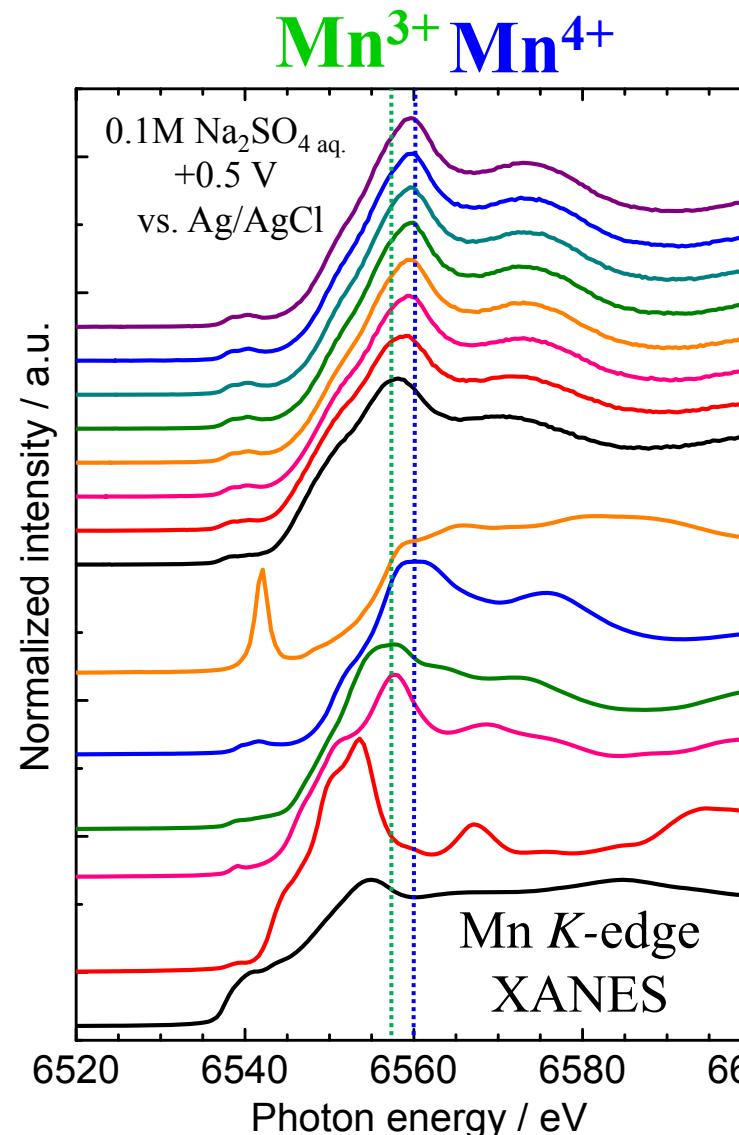
光電着前と光電着後のサンプルの光電極活性を比較



マンガン酸化物の担持による効率的な水分解を確認



光照射下でのMn-K端XANESスペクトルの変化

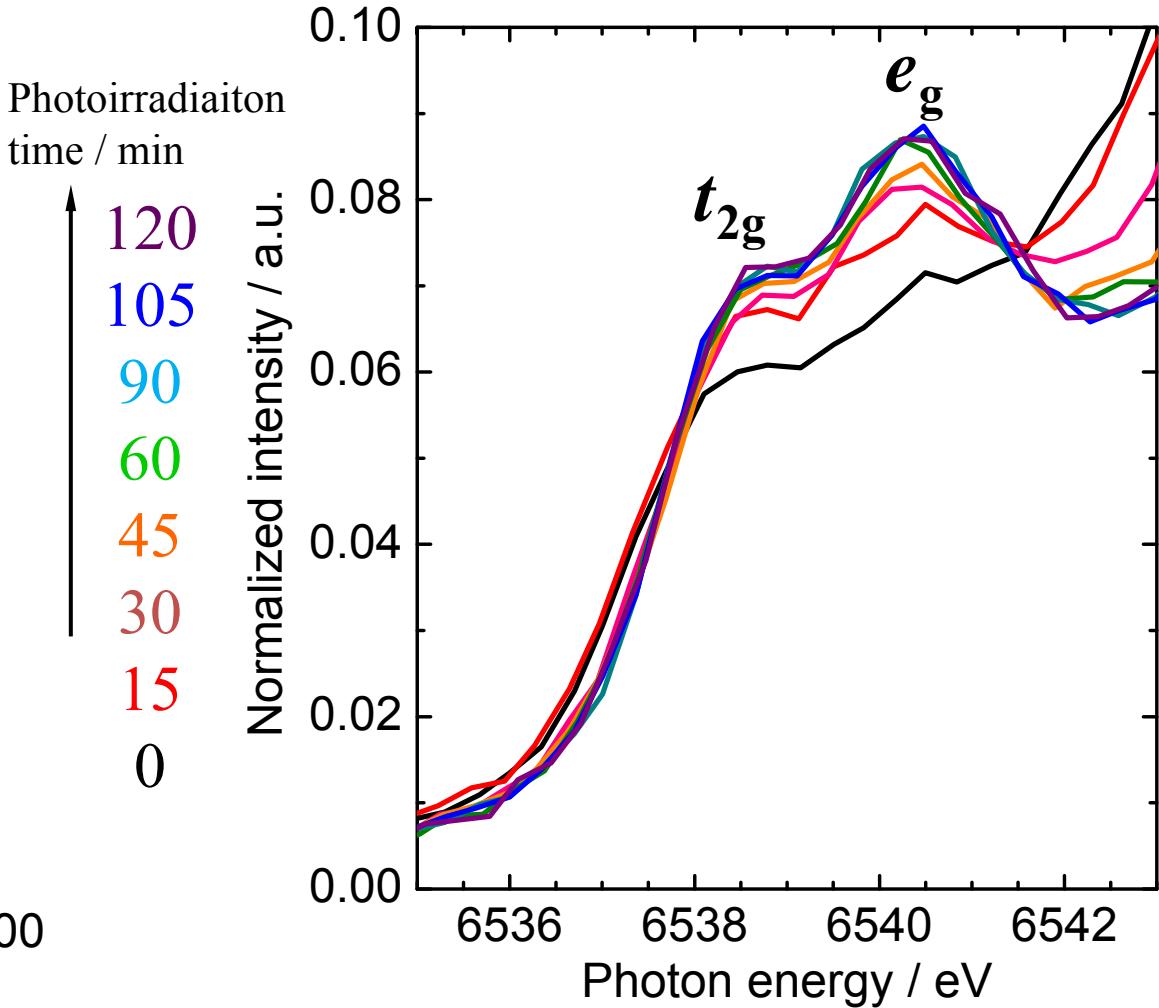
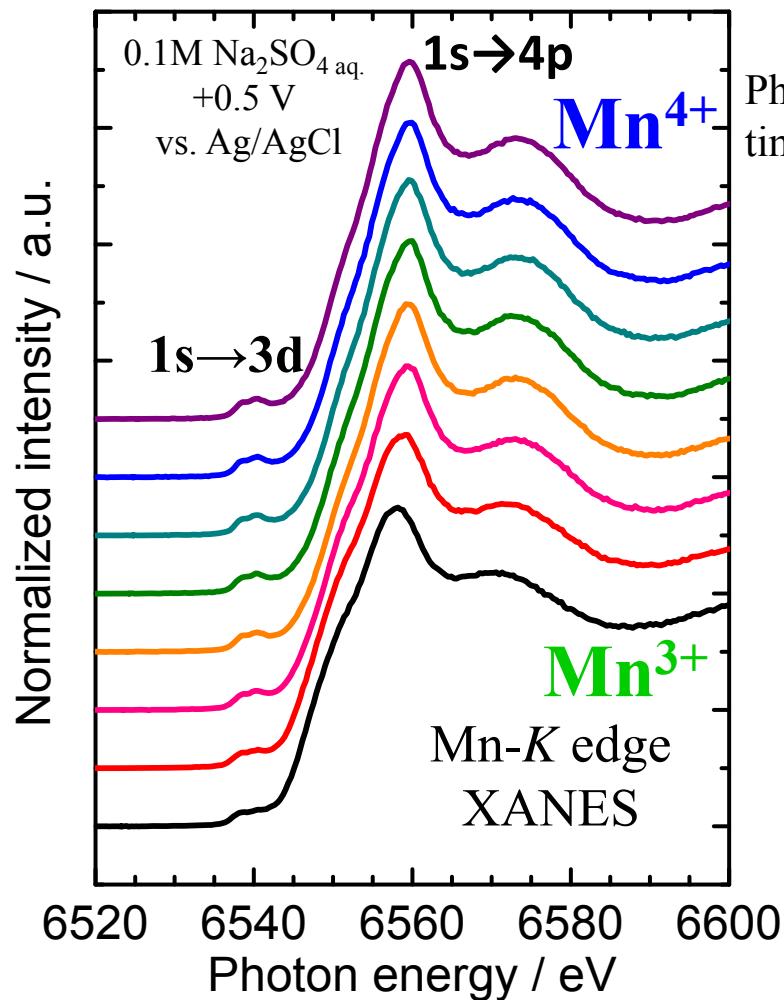


励起ホールによるマンガン酸化物の酸化を観測



光照射に伴うMn 1s-3d遷移の変化

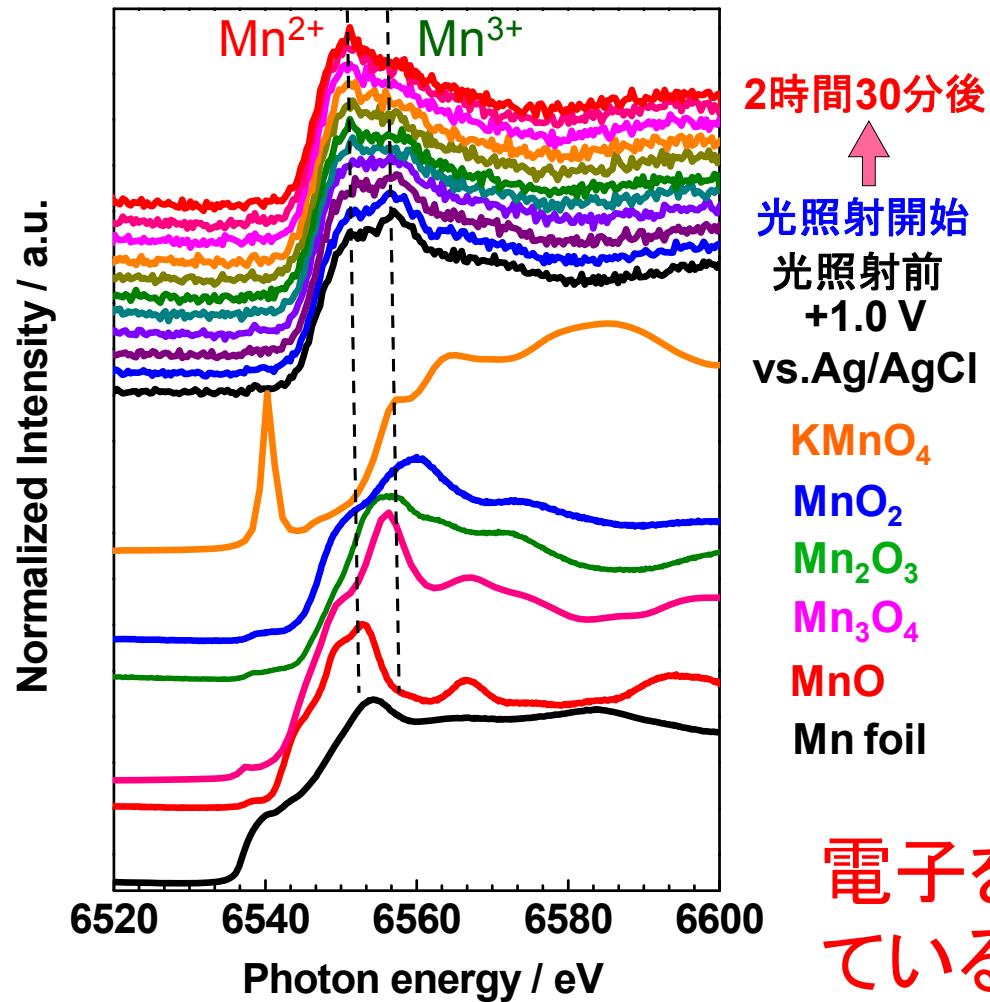
光照射時間が増えるに従い、1s-3d遷移の強度が増加



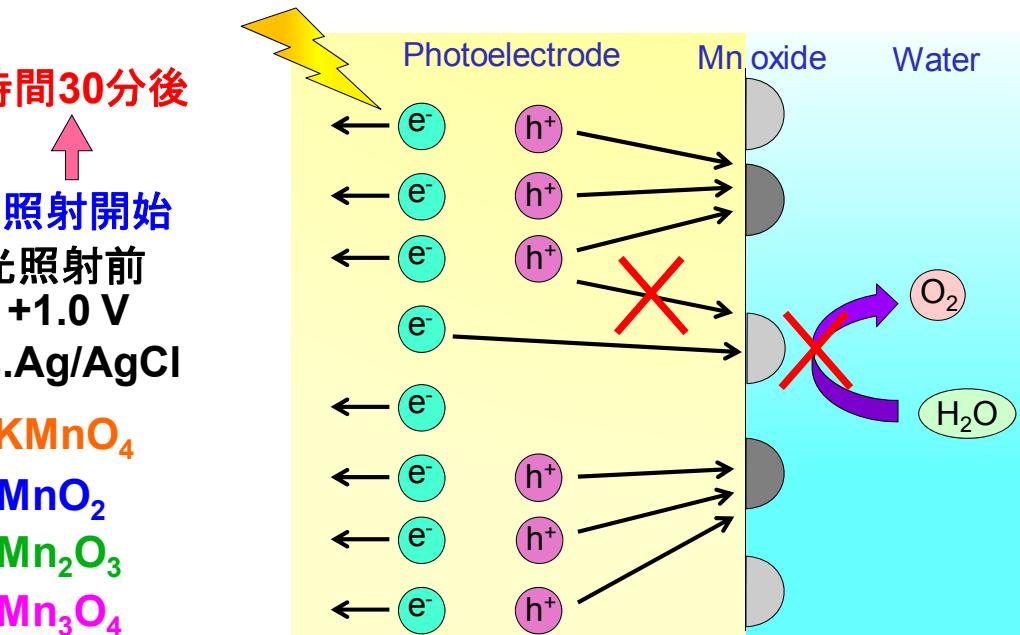
1s-3d遷移から、Mnの e_g 軌道にホールが入る様子が分かる



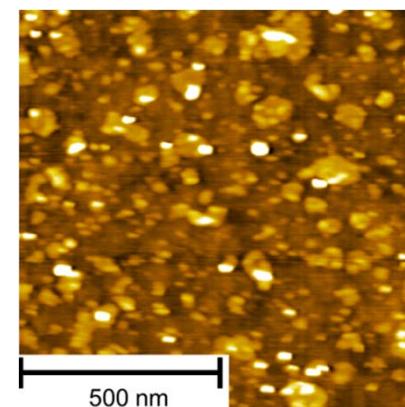
助触媒粒子が表面に分散している場合



一部の酸化マンガン粒子には逆の
キャリアである励起電子が移動

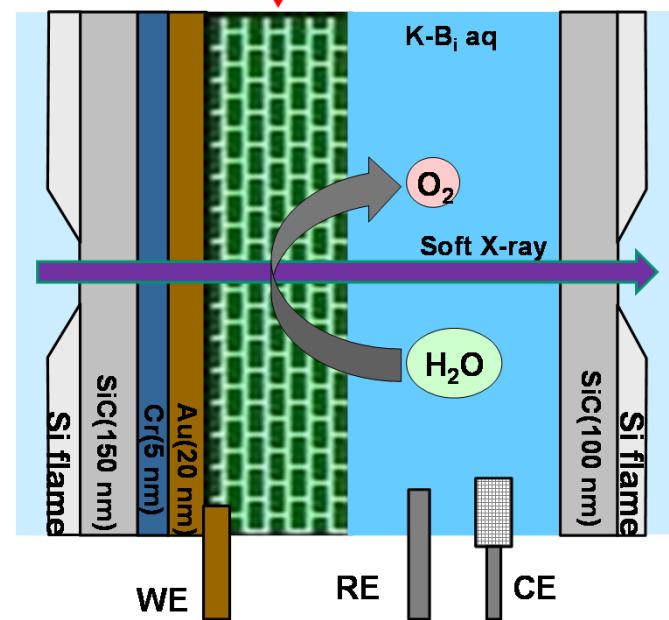
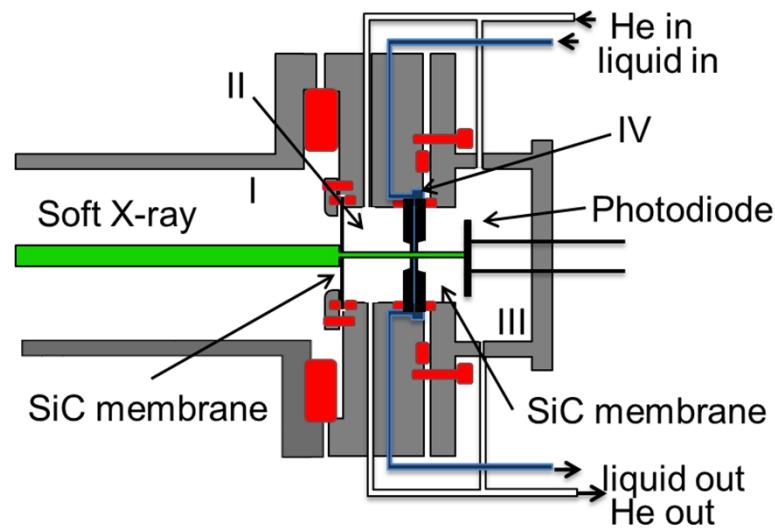
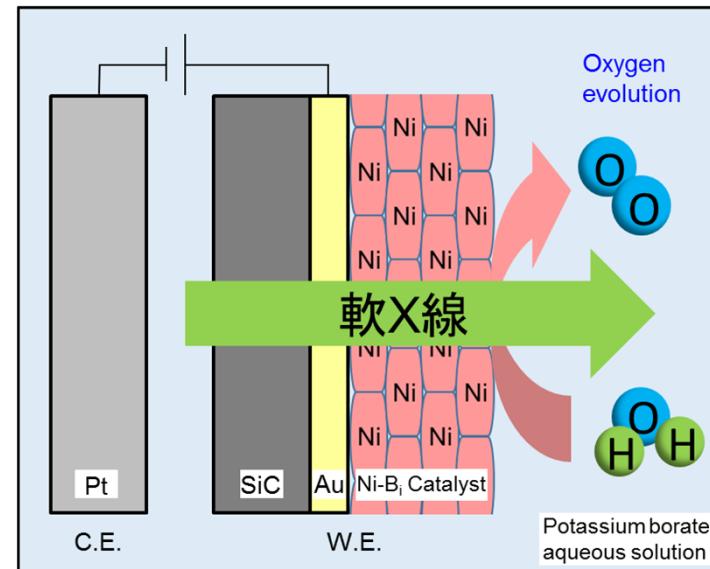
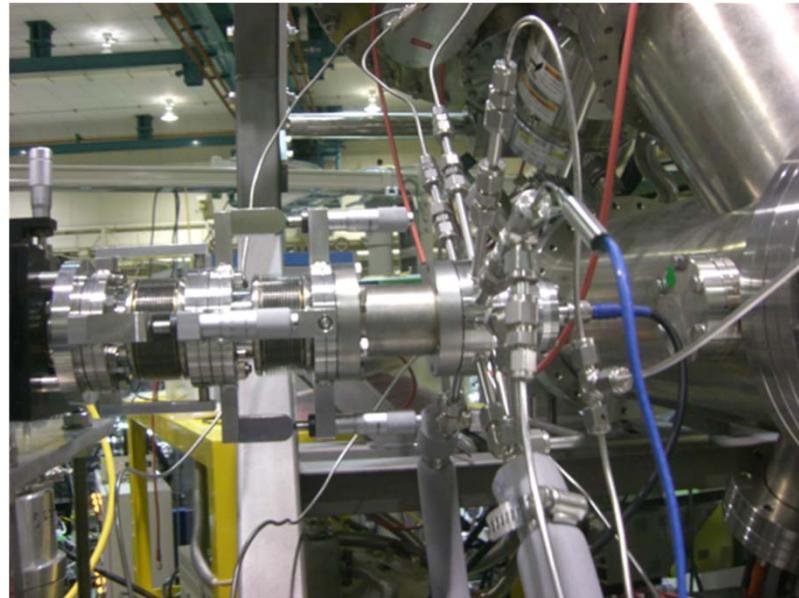


電子を受取っ
ている助触媒
粒子がある!!





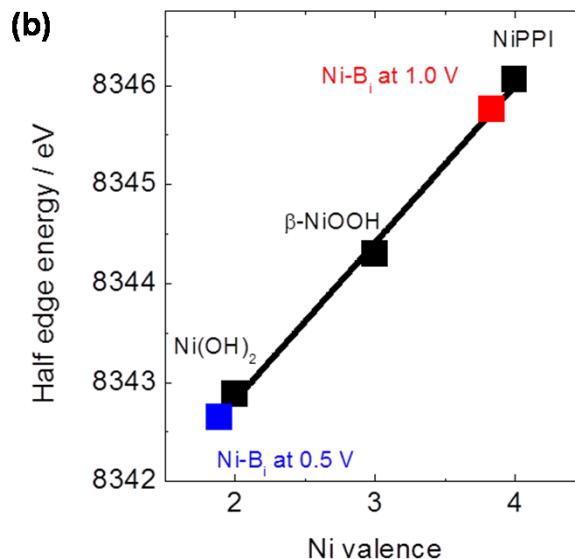
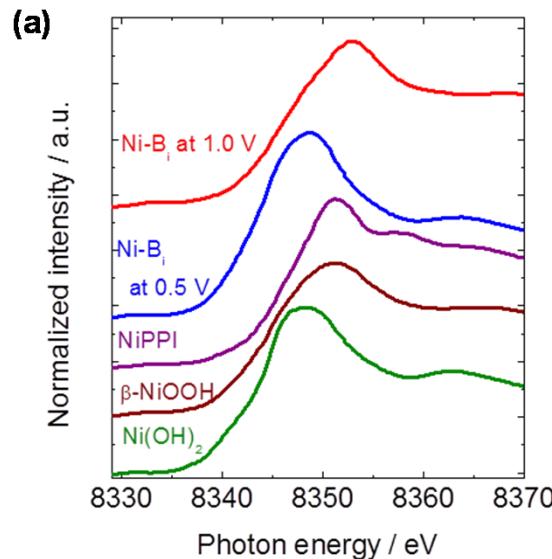
透過型軟X線電気化学XAFSによる酸素発生触媒のその場観測



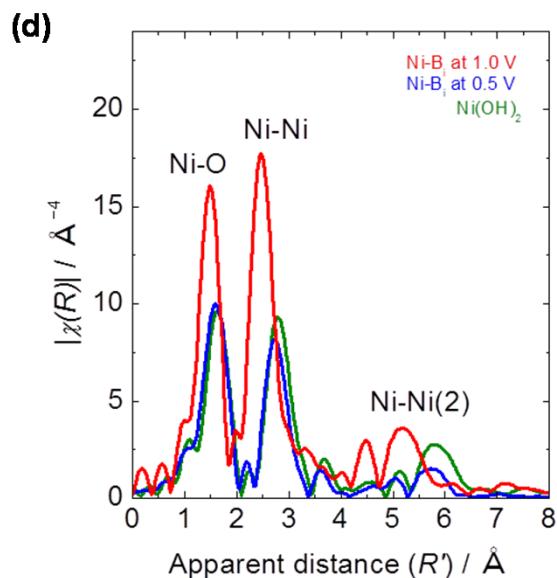
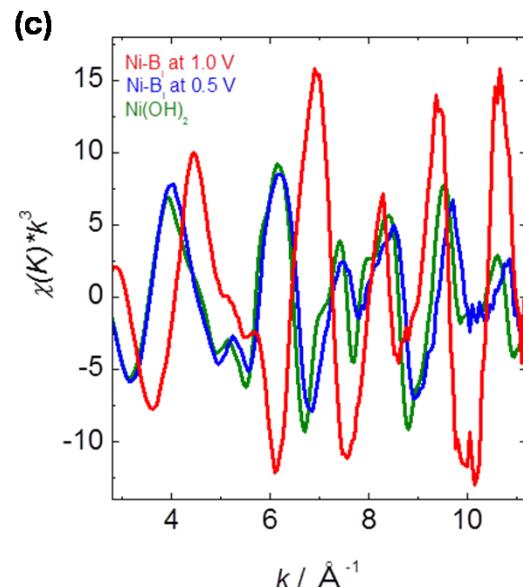
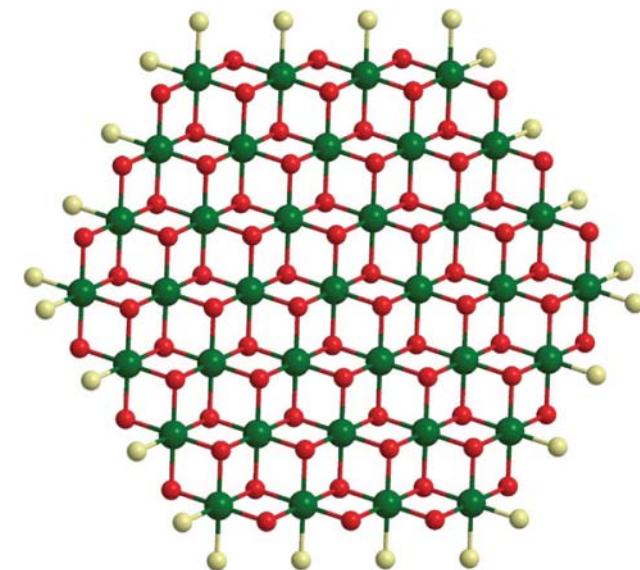


ホウ酸ニッケル(Ni-B_i)電極触媒

水分解時の酸素生成触媒を電気化学XAFS法によって測定



Ni-B_iクラスター



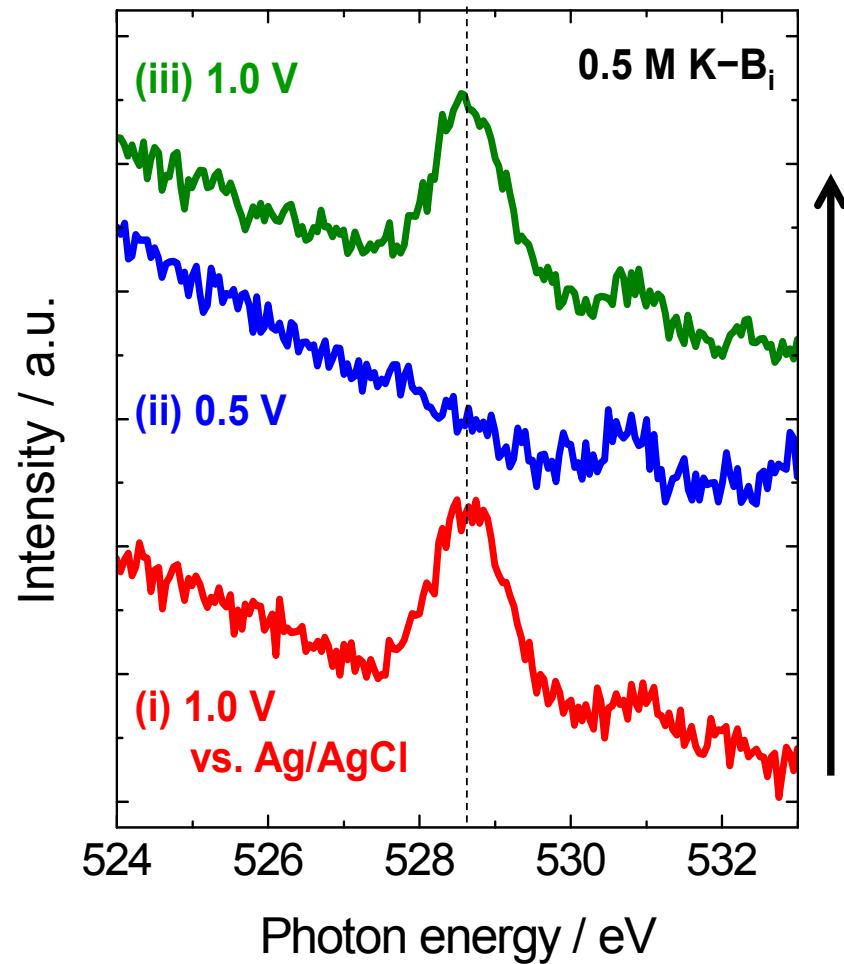
1.0 V印加でNi
が高酸化状態

酸素はどうなって
いるのか？

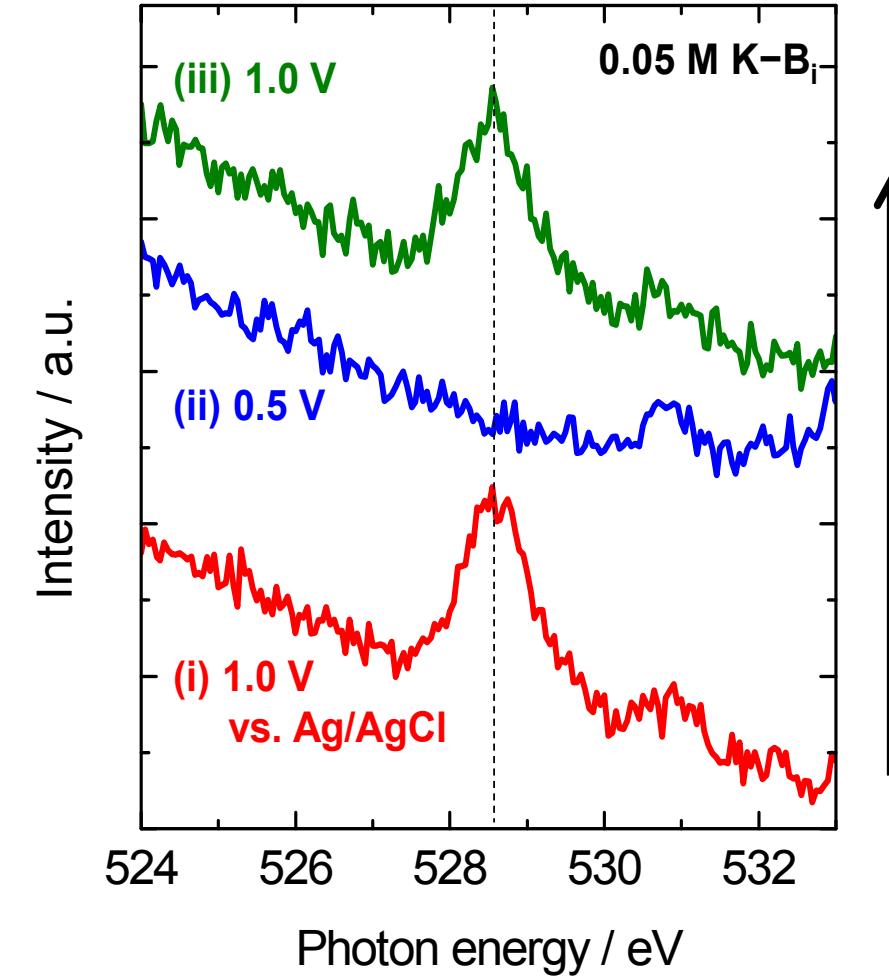


ホウ酸ニッケル(Ni-B_i)電極触媒の*in-situ* O-K端XAFSスペクトル

(a)



(b)

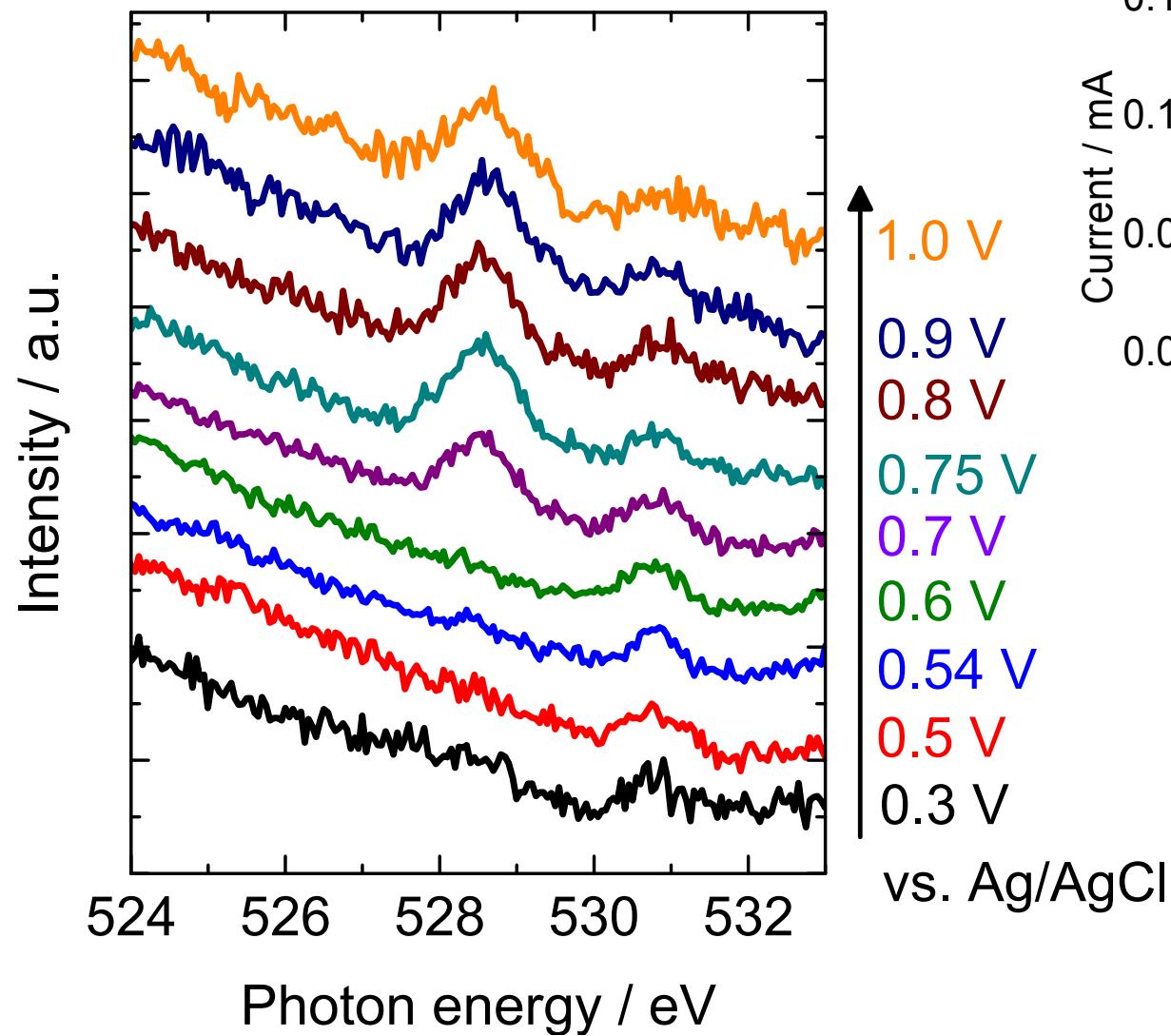


1.0 Vのとき水分解の活性が生じるので、
そのとき生じる化学種を捉えることができた

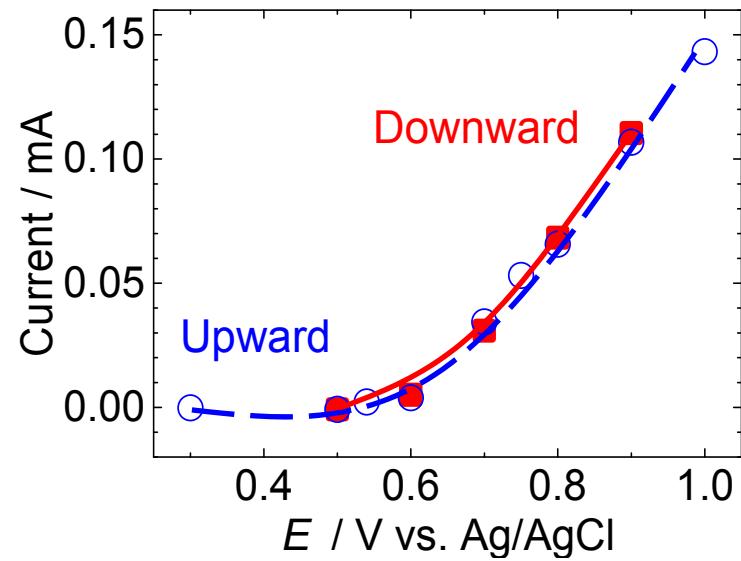


ホウ酸ニッケル(Ni-B_i)電極触媒の*in-situ* O-K端XAFSスペクトル

in-situ O-K端XAFS



酸素発生電流

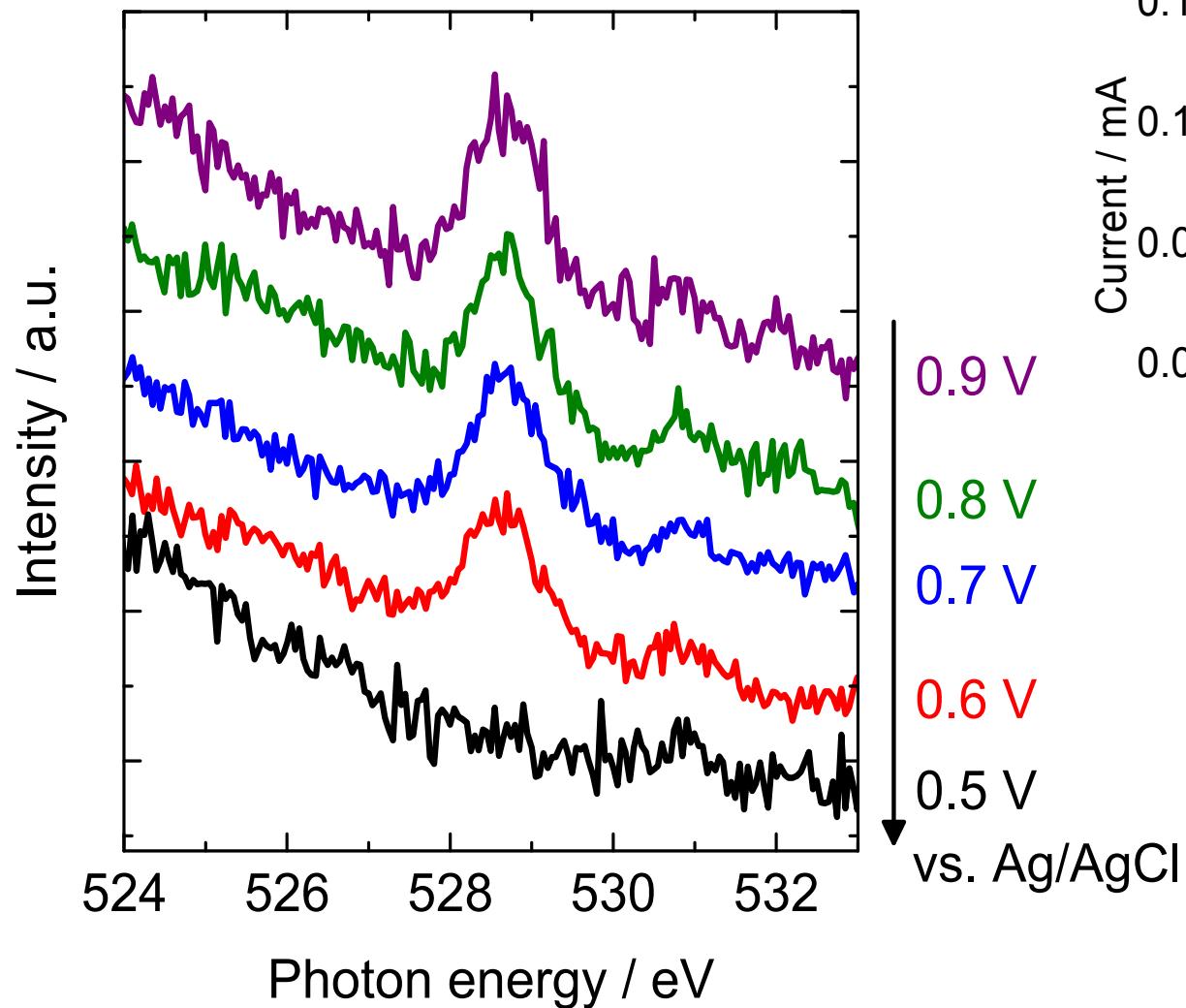


酸素発生電流と共に
現れるピーク

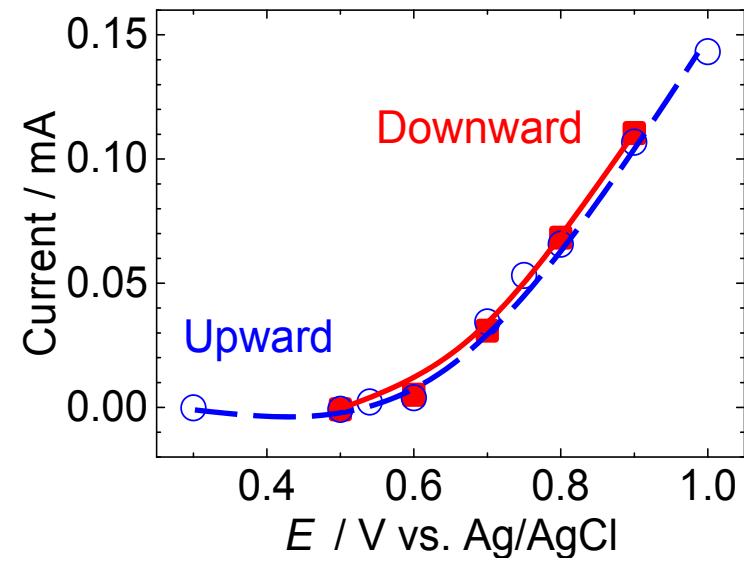


ホウ酸ニッケル(Ni-B_i)電極触媒の*in-situ* O-K端XAFSスペクトル

in-situ O-K端XAFS



酸素発生電流



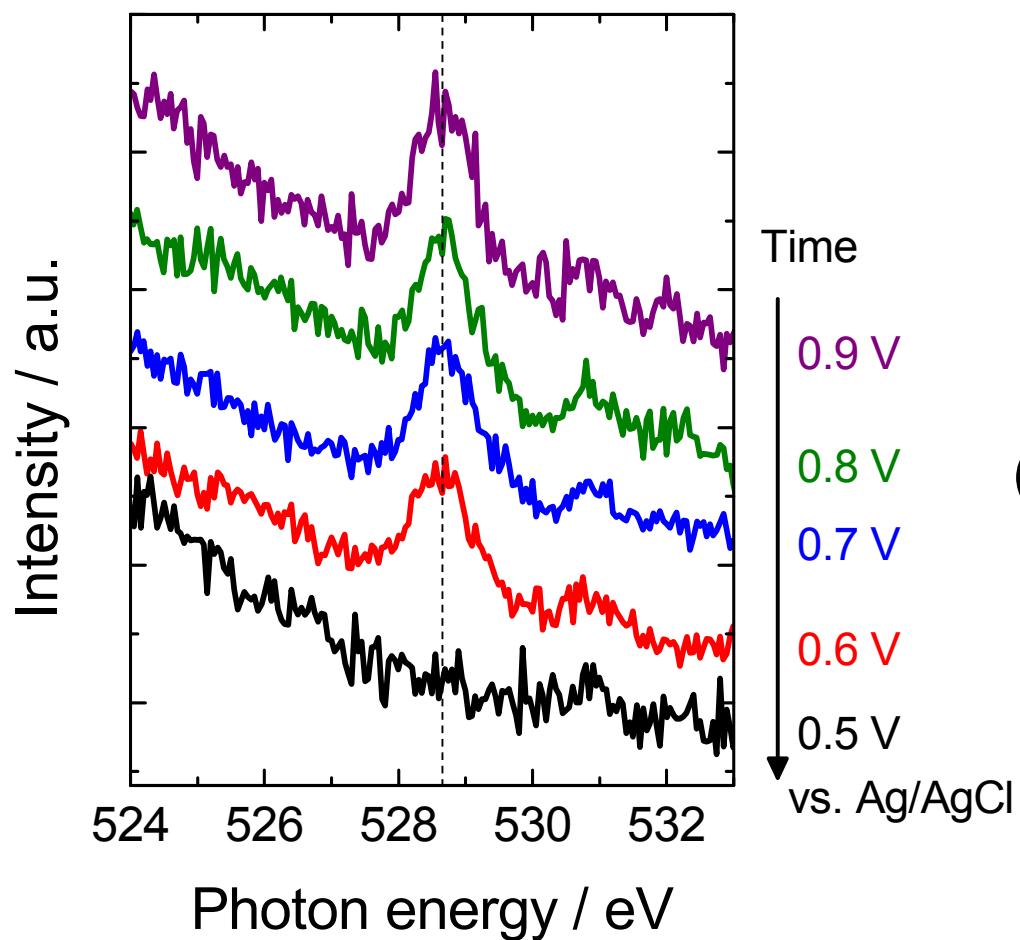
酸素発生電流と共に
現れるピーク



ホウ酸ニッケル(Ni-B_i)電極触媒の*in-situ* O-K端XAFSスペクトル

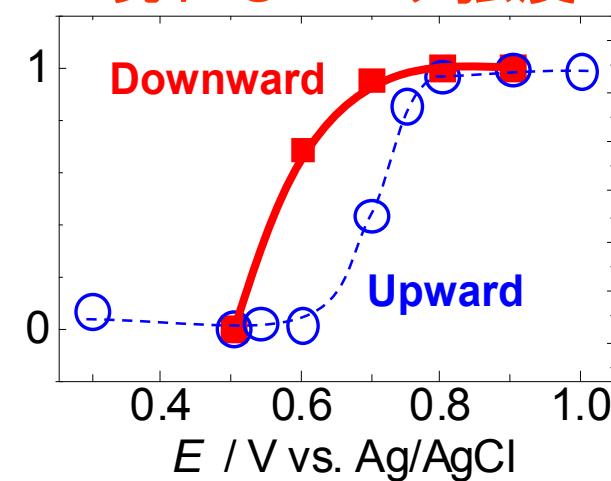
in-situ O-K端XAFS

(a)

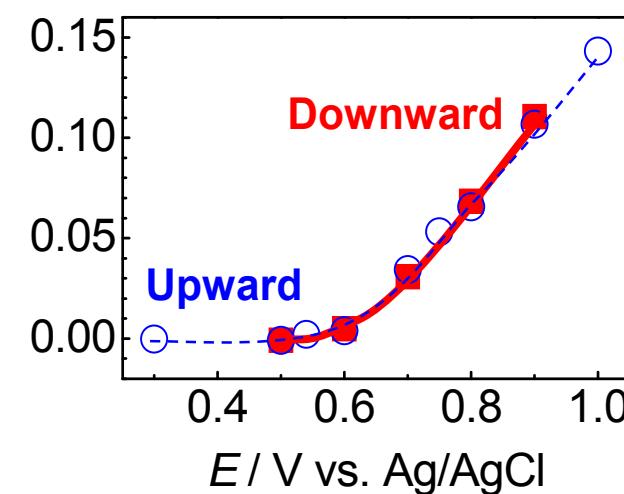


(b)

酸素発生電流と共に
現れるピーク強度



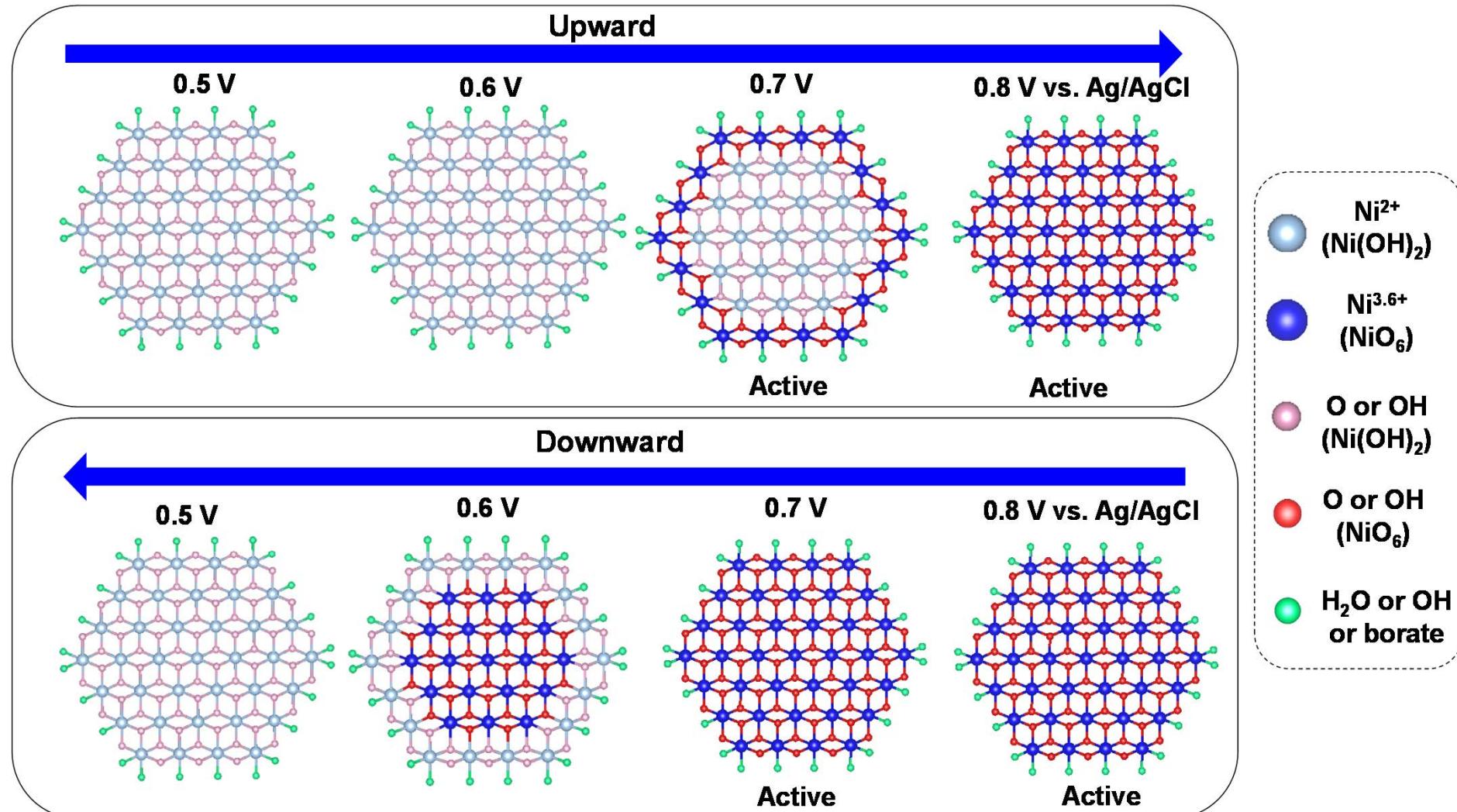
(c)



酸素発生電流



ホウ酸ニッケル(Ni-B_i)電極触媒の活性化モデル



クラスターの外側が活性サイト

M. Yoshida et al., *J. Phys. Chem. C*, **119**, 19279 (2015).



おわりに

- 実作動条件に近い環境下で反応が進行している触媒をin-situで観測する軟X線分光手法を紹介した。
- 応用例として、CO酸化反応に活性な白金族金属表面の活性相および水分解に活性な酸素生成電極触媒の化学状態について紹介した。
- 触媒が機能しているとき始めてできるものがあるので、**実在環境で動いているものの情報**を得ることが反応機構の理解に重要である。

学理から実用触媒の開拓へ

Acknowledgements

NAP-XPS関連



Keio Univ.

Dr. Masaaki Yoshida
Mr. Yuji Monya (D3)
Mr. Ryo Toyoshima (D2)
Mr. Kazuma Suzuki (M2)
Mr. Masahiro Shimura
(B4)



Photon Factory
Prof. Kenta Amemiya
Prof. Kazuhiko Mase
Prof. Hitoshi Abe



Prof. B. Simon Mun



Univ. Tokyo Prof. Iwao Matsuda

MAX-Lab Prof. Jesper N. Andersen
Prof. Joachim Schnadt
Dr. Jan Knudsen



Acknowledgements

電気化学XAFS関連



Keio Univ.

Dr. Masaaki Yoshida
Mr. Takumi Yomogida
Mr. Yosuke Mitsutomi
Mr. Tsuyoshi Iida



UVSOR-III

Prof. Nobuhiro Kosugi
Dr. Masanari Nagasaka
Dr. Yuto Yuzawa



Photon Factory

Prof. Hitoshi Abe
Dr. Hiroaki Nitani



NIMS

Prof. Kohei Uosaki
Dr. Takuya Masuda



Hokkaido Univ.

Prof. Kiyotaka Asakura
Prof. Satoru Takakusagi



SPring-8

Prof. Tomoya Uruga
Dr. Kiyofumi Nitta
Dr. Kazuo Kato
Dr. Toshiaki Ina